

# Test Report

## (EN 50155 & EN 50121-3-2)

**Report No.:** CEBDBO-WTW-P22010294-1

**Test Model:** AIC-110

**Series Model:** AIC-100 Series, AIC-1XXXXXXXXXXXXXXXXX ("X" can be 0-9, A-Z or blank for marketing purpose)

**Received Date:** 2022/1/8

**Test Date:** 2022/3/23 ~ 2022/4/7

**Issued Date:** 2022/4/21

**Applicant:** Vecow Co., Ltd.

**Address:** 3F., No.10, Jiankang Rd., Zhonghe Dist., New Taipei City 23586, Taiwan

**Issued By:** Bureau Veritas Consumer Products Services (H.K.) Ltd., Taoyuan Branch  
Lin Kou Laboratories

**Lab Address:** No. 47-2, 14th Ling, Chia Pau Vil., Lin Kou Dist., New Taipei City, Taiwan



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## Table of Contents

<b>Release Control Record .....</b>	<b>4</b>
<b>1 Certificate of Conformity .....</b>	<b>5</b>
<b>2 Summary of Test Results .....</b>	<b>6</b>
2.1 Performance Criteria .....	9
2.2 Measurement Uncertainty .....	9
2.3 Modification Record .....	9
<b>3 General Information .....</b>	<b>10</b>
3.1 Description of EUT .....	10
3.2 Features of EUT .....	10
3.3 Operating Modes of EUT and Determination of Worst Case Operating Mode .....	11
3.4 Test Program Used and Operation Descriptions .....	11
3.5 Primary Clock Frequencies of Internal Source .....	11
<b>4 Configuration and Connections with EUT .....</b>	<b>12</b>
4.1 Connection Diagram of EUT and Peripheral Devices .....	12
4.2 Configuration of Peripheral Devices and Cable Connections .....	14
<b>5 Conducted Disturbance at Auxiliary a.c. or d.c. Power Ports .....</b>	<b>16</b>
5.1 Limits .....	16
5.2 Test Instruments .....	16
5.3 Test Arrangement .....	17
5.4 Test Results .....	18
<b>6 Radiated Disturbance up to 1 GHz .....</b>	<b>20</b>
6.1 Limits .....	20
6.2 Test Instruments .....	20
6.3 Test Arrangement .....	21
6.4 Test Results .....	22
<b>7 Radiated Disturbance above 1 GHz.....</b>	<b>24</b>
7.1 Limits .....	24
7.2 Test Instruments .....	25
7.3 Test Arrangement .....	26
7.4 Test Results .....	27
<b>8 Harmonics Current Measurement .....</b>	<b>29</b>
8.1 Limits .....	29
8.2 Classification of Equipment .....	29
8.3 Test Instruments .....	29
8.4 Test Arrangement .....	30
8.5 Test Results .....	30
<b>9 Voltage Fluctuations and Flicker Measurement.....</b>	<b>31</b>
9.1 Limits .....	31
9.2 Test Instruments .....	31
9.3 Test Arrangement .....	31
9.4 Test Results .....	32
<b>10 Electrostatic Discharge Immunity Test (ESD) .....</b>	<b>33</b>
10.1 Test Specification .....	33
10.2 Test Instruments .....	33
10.3 Test Arrangement .....	34
10.4 Test Results .....	35
<b>11 Radio-frequency Electromagnetic Field Immunity Test (RS).....</b>	<b>38</b>
11.1 Test Specification .....	38

11.2	Test Instruments .....	39
11.3	Test Arrangement .....	40
11.4	Test Results .....	40
<b>12</b>	<b>Electrical Fast Transient/Burst Immunity Test (EFT).....</b>	<b>41</b>
12.1	Test Specification .....	41
12.2	Test Instruments .....	41
12.3	Test Arrangement .....	42
12.4	Test Results .....	43
<b>13</b>	<b>Surge Immunity Test .....</b>	<b>44</b>
13.1	Test Specification .....	44
13.2	Test Instruments .....	44
13.3	Test Arrangement .....	45
13.4	Test Results .....	45
<b>14</b>	<b>Immunity to Conducted Disturbances Induced by RF Fields (CS) .....</b>	<b>46</b>
14.1	Test Specification .....	46
14.2	Test Instruments .....	46
14.3	Test Arrangement .....	48
14.4	Test Results .....	49
<b>15</b>	<b>Pictures of Test Arrangements .....</b>	<b>50</b>
15.1	Conducted Disturbance at Auxiliary a.c. or d.c. power ports.....	50
15.2	Radiated Disturbance up to 1 GHz.....	51
15.3	Radiated Disturbance above 1 GHz.....	52
15.4	Harmonics Current, Voltage Fluctuations and Flicker Measurement.....	53
15.5	Electrostatic Discharge Immunity Test (ESD).....	53
15.6	Radio-frequency Electromagnetic Field Immunity Test (RS).....	54
15.7	Fast Transients (EFT).....	55
15.8	Surge .....	56
15.9	Radio-frequency common mode (CS).....	57
<b>Appendix – Information of the Testing Laboratories .....</b>		<b>58</b>

## Release Control Record

Issue No.	Description	Date Issued
CEBDBO-WTW-P22010294-1	Original release.	2022/4/21

## 1 Certificate of Conformity

**Product:** Arm-based IoT Gateway System

**Brand:** Vecow

**Test Model:** AIC-110

**Series Model:** AIC-100 Series, AIC-1XXXXXXXXXXXXXXXXX ("X" can be 0-9, A-Z or blank for marketing purpose)

**Sample Status:** Engineering sample

**Applicant:** Vecow Co., Ltd.

**Test Date:** 2022/3/23 ~ 2022/4/7

**Standards:** EN 50155:2017, Clause 13.4.8

EN 61000-3-2:2014

EN IEC 61000-3-2:2019+A1:2021

EN 61000-3-3:2013+A2:2021

EN 50121-1:2017

EN 50121-3-2:2016

EN 61000-4-2:2009

EN 61000-4-3:2006 +A1:2008 +A2:2010

EN IEC 61000-4-3:2020

EN 61000-4-4:2012

EN 61000-4-5:2014 +A1:2017

EN 61000-4-6:2014 +AC:2015

The above equipment has been tested by **Bureau Veritas Consumer Products Services (H.K.) Ltd., Taoyuan Branch**, and found compliance with the requirement of the above standards. The test record, data evaluation & Equipment Under Test (EUT) configurations represented herein are true and accurate accounts of the measurements of the sample's EMC characteristics under the conditions specified in this report.

**Prepared by :** Ivy Lin , **Date:** 2022/4/21  
Ivy Lin / Specialist

**Approved by :** Jim Hsiang , **Date:** 2022/4/21  
Jim Hsiang / Associate Technical Manager

## 2 Summary of Test Results

EN 50121-3-2:2016, Emission requirements,  
EN 50155:2017, Clause 13.4.8

Port	Test Item / specifications	Result/Remarks	Verdict
Auxiliary a.c. or d.c. power ports - Auxiliary supply sinusoidal a.c. or d.c.	Conducted disturbance 150 kHz- 500 kHz: 99 dB $\mu$ V quasi-peak 500 kHz- 30 MHz: 93 dB $\mu$ V quasi-peak	Minimum passing margin is -49.47 dB at 1.43473 MHz	Pass
Auxiliary a.c. or d.c. power ports – AC power outlet port for public use	Conducted disturbance 50 Hz- 2 kHz: THD <8% (THD: total harmonic distortion)	Test not applicable because the port does not exist.	N/A
Battery referenced ports - Battery power supply	Conducted disturbance 150 kHz- 500 kHz: 99 dB $\mu$ V quasi-peak 500 kHz- 30 MHz: 93 dB $\mu$ V quasi-peak	Test not applicable because the port does not exist.	N/A
Enclosure	Radiated disturbance 30 MHz- 230 MHz: 40 dB $\mu$ V/m quasi-peak 230 MHz -1 GHz: 47 dB $\mu$ V/m quasi-peak	Minimum passing margin is -3.37 dB at 396.18 MHz	Pass
Enclosure	Radiated disturbance 1 GHz- 3 GHz: 76 dB $\mu$ V/m peak 56 dB $\mu$ V/m average 3 GHz - 6 GHz: 80 dB $\mu$ V/m peak 60 dB $\mu$ V/m average	Minimum passing margin is -14.62 dB at 1440.02 MHz	Pass

Emission requirements

Standard	Test Item / specifications	Result/Remarks	Verdict
EN 61000-3-2:2014 EN IEC 61000-3-2:2019+A1:2021	Harmonic current emissions	The power consumption of EUT is less than 75W and no limits apply	Pass
EN 61000-3-3:2013+A2:2021	Voltage fluctuations and flicker	$P_{st} \leq 1.0$ $d_{max} \leq 4\%$ $P_{lt} \leq 0.65$ $d_c \leq 3.3\%$ $T_{max} \leq 500ms$	Pass

EN 50121-3-2:2016, Immunity requirements,  
EN 50155:2017, Clause 13.4.8

Table Clause	Basic standard	Port	Test Item / specifications	Result/Remarks	Verdict
3.1	EN 61000-4-6:2014 +AC:2015	Battery referenced ports (except at the output of energy sources), Auxiliary a.c. power input ports (rated voltage $\leq$ 400 Vrms)	Radio-frequency common mode (CS) 80% AM (1kHz) 0.15-80 MHz, 10V Performance Criterion A	Performance Criterion A	Pass
3.2	EN 61000-4-4:2012	Battery referenced ports (except at the output of energy sources), Auxiliary a.c. power input ports (rated voltage $\leq$ 400 Vrms)	Fast Transients (EFT) 5/50 ( $t_r/t_w$ ) ns, 5kHz $\pm$ 2kV Performance Criterion A	Performance Criterion A	Pass
3.3	EN 61000-4-5:2014 +A1:2017	Battery referenced ports (except at the output of energy sources), Auxiliary a.c. power input ports (rated voltage $\leq$ 400 Vrms)	Surges 1.2/50 (8/20) ( $T_r/T_d$ ) $\mu$ s Line to ground: $\pm$ 2kV 42 $\Omega$ , 0.5 $\mu$ F Line to line: $\pm$ 1kV 42 $\Omega$ , 0.5 $\mu$ F Performance Criterion B	Performance Criterion A	Pass
4.1	EN 61000-4-6:2014 +AC:2015	Signal & communication, process measurement & control ports	Radio-frequency common mode (CS) 80% AM (1kHz) 0.15-80 MHz, 10V Performance Criterion A	Performance Criterion A	Pass
4.2	EN 61000-4-4:2012	Signal & communication, process measurement & control ports	Fast Transients (EFT) 5/50 ( $t_r/t_w$ ) ns, 5kHz $\pm$ 2kV, Capacitive clamp Performance Criterion A	Performance Criterion A	Pass
5.1	EN 61000-4-3:2006 +A1:2008 +A2:2010/ EN IEC 61000-4-3:2020	Enclosure ports	Radio-frequency electromagnetic field amplitude modulated (RS) <sup>1</sup> , 80% AM (1kHz) 80-800 MHz, 20V/m Performance Criterion A	Performance Criterion A	Pass
5.2	EN 61000-4-3:2006 +A1:2008 +A2:2010/ EN IEC 61000-4-3:2020	Enclosure ports	Radio-frequency electromagnetic field from digital mobile telephones (RS) <sup>2</sup> , 80% AM (1kHz) 800-1000 MHz, 20V/m 1400-2000 MHz, 10V/m 2000-2700 MHz, 5V/m 5100-6000 MHz, 3V/m Performance Criterion A	Performance Criterion A	Pass

EN 50121-3-2:2016, Immunity requirements,  
EN 50155:2017, Clause 13.4.8

Table Clause	Basic standard	Port	Test Item / specifications	Result/Remarks	Verdict
5.3	EN 61000-4-2:2009	Enclosure ports	Electrostatic Discharges (ESD) ±6kV Contact discharge ±8kV Air discharge Performance Criterion B	Performance Criterion B	Pass

Note 1: This limit applies to equipment mounted in the passenger compartments, drivers cab or external to the rolling stock (roof, underframe). For equipment mounted in all other areas a severity level of 10 V/m may be used.

Note 2: For large apparatus (e.g. traction drives, auxiliary converters) it is often not practical to perform the immunity test to radiated electromagnetic fields on the complete unit. In such cases the manufacturer should test susceptible sub-systems (e.g. control electronics). The test report should justify the selection or not of sub-systems and any assumptions made (e.g. reduction of field due to case shielding).

Note:

1. There is no deviation to the applied test methods and requirements covered by the scope of this report.
2. The above EN basic standards are applied with latest version if customer has no special requirement.
3. Determining compliance based on the results of the compliance measurement, not taking into account measurement instrumentation uncertainty.
4. N/A: Not Applicable



## 2.1 Performance Criteria

### General Performance Criteria

The general performance criteria apply for those ports for which no specific performance criteria are defined (e.g. auxiliary ports) in the report.

**Performance criterion A:** The apparatus shall continue to operate as intended during and after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. The performance level may be replaced by a permissible loss of performance. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, either of these may be derived from the product description and documentation, and from what the user may reasonably expect from the apparatus if used as intended..

**Performance criterion B:** The apparatus shall continue to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. The performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed. No change of actual operating state or stored data is allowed. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, either of these may be derived from the product description and documentation, and from what the user may reasonably expect from the apparatus if used as intended.

**Performance criterion C:** Temporary loss of function is allowed, provided the function is self-recoverable or can be restored by the operation of the controls.

## 2.2 Measurement Uncertainty

Where relevant, the following measurement uncertainty levels have been estimated for tests performed on the EUT as specified in CISPR 16-4-2:

Measurement	Expanded Uncertainty (k=2) ( $\pm$ )	Maximum allowable uncertainty ( $\pm$ )
Conducted disturbance at mains port using AMN, 150kHz ~ 30MHz	2.94 dB	3.4 dB ( $U_{\text{CISPR}}$ )
Radiated disturbance, 30MHz ~ 1GHz	4.30 dB	6.3 dB ( $U_{\text{CISPR}}$ )
Radiated disturbance, 1GHz ~ 6GHz	4.64 dB	5.2 dB ( $U_{\text{CISPR}}$ )

The other instruments specified are routine verified to remain within the calibrated levels, no measurement uncertainty is required to be calculated.

## 2.3 Modification Record

There were no modifications required for compliance.

### 3 General Information

#### 3.1 Description of EUT

Product	Arm-based IoT Gateway System
Brand	Vecow
Test Model	AIC-110
Series Model	AIC-100 Series, AIC-1XXXXXXXXXXXXXXXXX ("X" can be 0-9, A-Z or blank for marketing purpose)
Model Difference	For marketing purpose.
Sample Status	Engineering sample
Operating Software	Debian Stretch R01
Power Supply Rating	Refer to Note as below
Accessory Device	Adapter
Data Cable Supplied	Shielded USB cable (1.0m)

Note:

The EUT uses following adapter.

Brand	FSP
Model	FSP120-AABN2
Input Power	100-240Vac, 1.8A, 50-60Hz
Output Power	24Vdc, 5.0A, 120W
Power Line	DC cable (1.5m) with one ferrite core.

#### 3.2 Features of EUT

1. The tests reported herein were performed according to the method specified by Vecow Co., Ltd., for detailed feature description, please refer to the manufacturer's specifications or user's manual.
2. The EUT was configured with the following key components:

Component	Vendor / Model No. /Spec
CPU	NXP i.MX6ULL Arm® Cortex® -A7, up to 900MHz
RAM	DDR3L SDRAM, 512MB

### 3.3 Operating Modes of EUT and Determination of Worst Case Operating Mode

Test mode is presented in the report as below.

Mode	Test Condition	Input Power
A	Full System	230Vac/ 50Hz

### 3.4 Test Program Used and Operation Descriptions

- a. Turned on the power of all equipment.
- b. Notebook ran a test program to enable all functions of EUT.
- c. Notebook read and wrote messages from USB Flash Drive via EUT.
- d. Notebook sent and received messages to/from two Notebooks (kept in a remote area) via EUT (command "PING") with two STP LAN cables (10m each).
- e. Steps c-e were repeated.

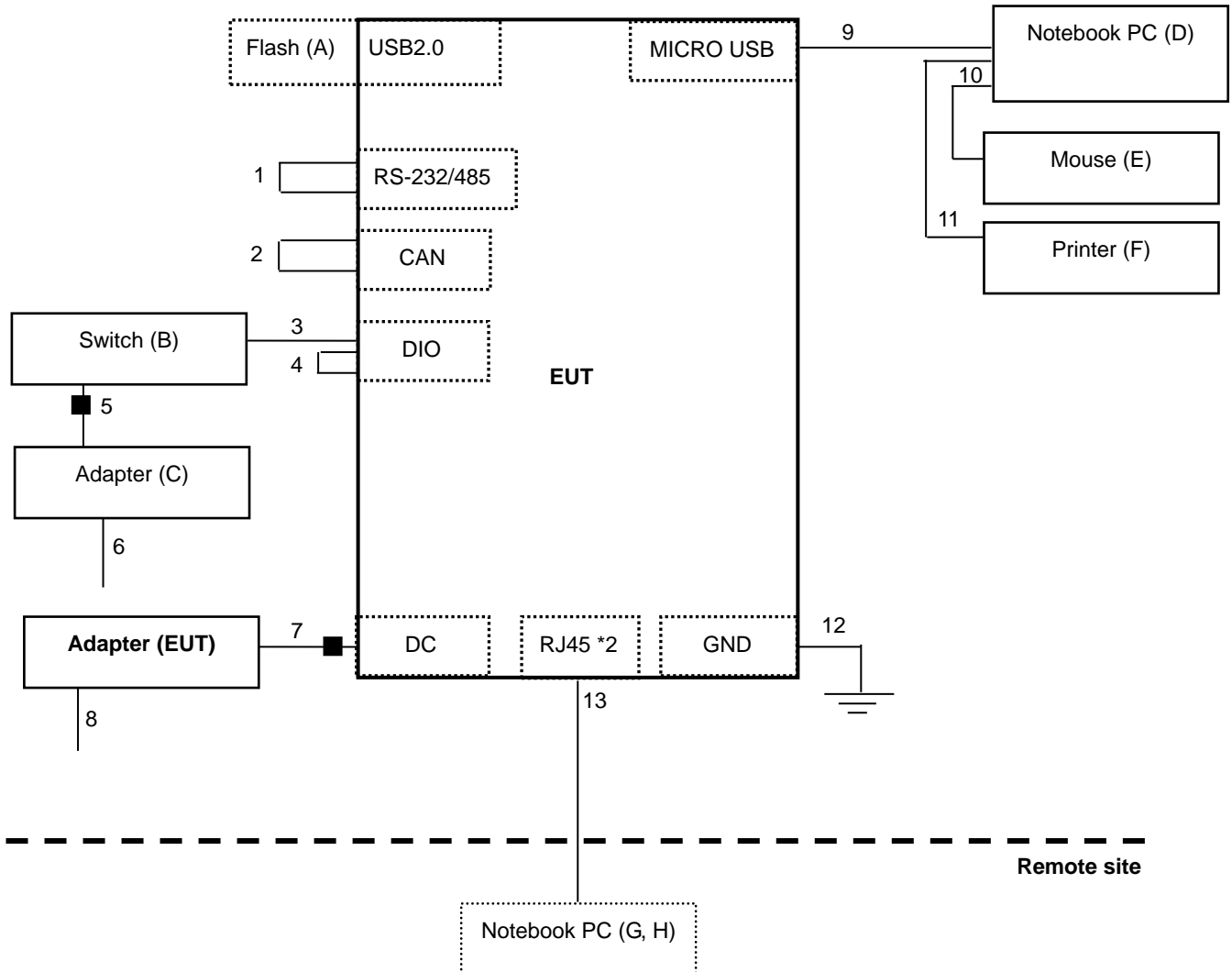
### 3.5 Primary Clock Frequencies of Internal Source

The highest frequency generated or used within the EUT or on which the EUT operates or tunes is 900 MHz, provided by Vecow Co., Ltd., for detailed internal source, please refer to the manufacturer's specifications.

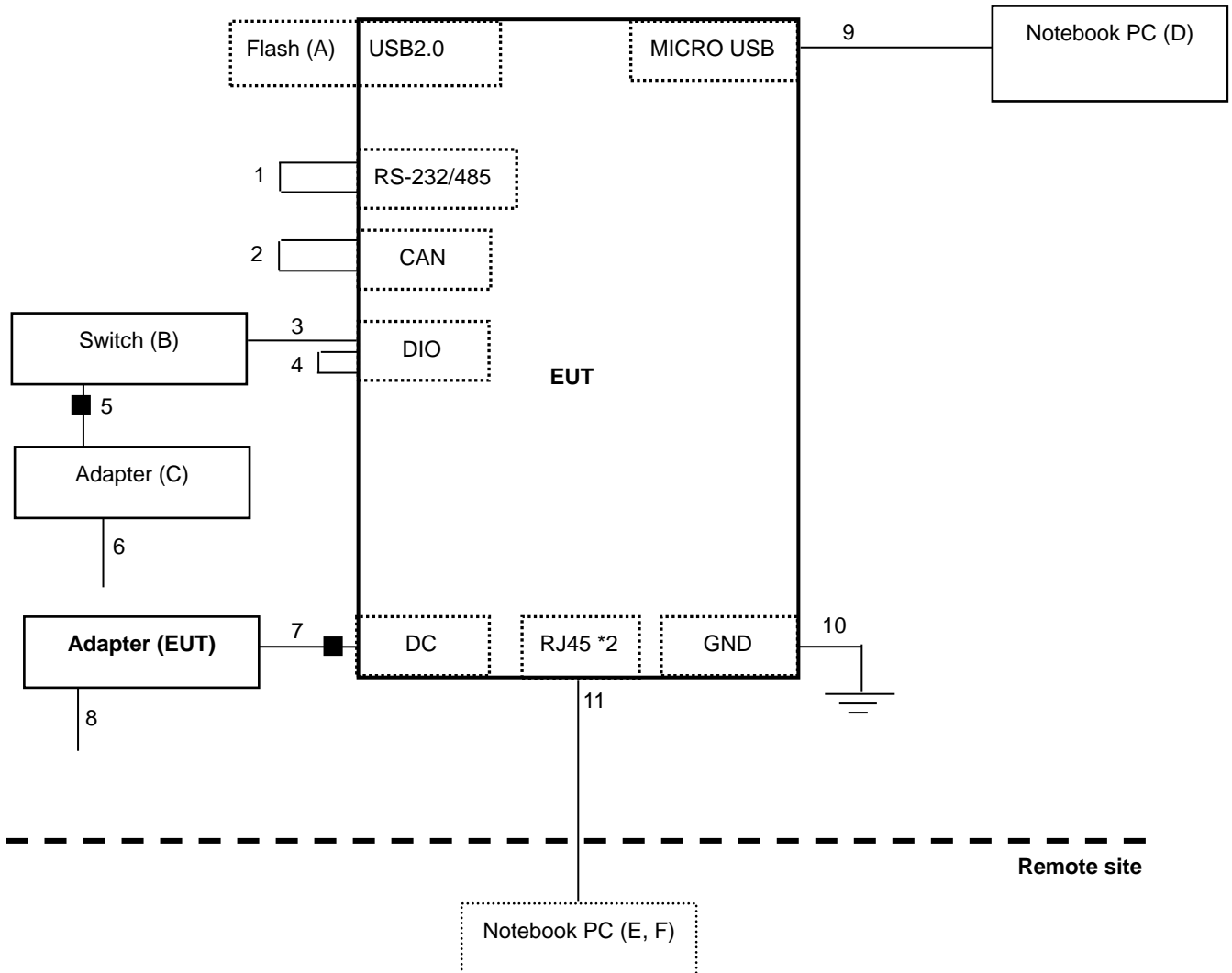
## 4 Configuration and Connections with EUT

### 4.1 Connection Diagram of EUT and Peripheral Devices

Emission tests (Harmonics & Flicker excluded):



Harmonics & Flicker & Immunity tests:



## 4.2 Configuration of Peripheral Devices and Cable Connections

Emission tests (Harmonics & Flicker excluded):

ID	Product	Brand	Model No.	Serial No.	FCC ID	Remarks
A	FLASH	SP	MOBILE C31	N/A	N/A	Provided by Lab
B	SWITCH	N/A	N/A	N/A	N/A	Supplied by applicant
C	ADAPTER	CWT	KPL-060F-VI	N/A	N/A	Supplied by applicant
D	Notebook PC	DELL	P41G	FT4W952	N/A	Provided by Lab
E	USB Mouse	DELL	MOCZUL	CN-049TWY-PRC00-77B-007R	N/A	Provided by Lab
F	PRINTER	HP	HP Officejet Pro 251dw	CN62OCV0JN	B94SDGOB1191	Provided by Lab
G	Notebook PC	SONY	SVS151A12P	275548477001024	N/A	Provided by Lab
H	Notebook PC	ASUS	PU401L	ECNXC012528528	N/A	Provided by Lab

ID	Cable Descriptions	Qty.	Length (m)	Shielding (Yes/No)	Cores (Qty.)	Remarks
1	I/O cable	2	0.01	No	0	Supplied by applicant
2	I/O cable	2	0.05	No	0	Supplied by applicant
3	DC power cable	3	0.1	No	0	Supplied by applicant
4	I/O cable	8	0.01	No	0	Supplied by applicant
5	DC power cable	1	1.2	No	1	Supplied by applicant
6	AC power cable	1	1.8	No	0	Provided by Lab
7	DC power cable	1	1.8	No	1	Supplied by applicant
8	AC power cable	1	1.8	No	0	Provided by Lab
9	Micro USB cable	1	1	Yes	0	Supplied by applicant
10	USB 2.0 cable	1	1.8	Yes	0	Provided by Lab
11	USB 2.0 cable	1	1.8	Yes	0	Provided by Lab
12	GND cable	1	1.5	No	0	Provided by Lab
13	RJ45 Cable	2	10	Yes	0	Provided by Lab

Harmonics, Flicker, Immunity tests:

ID	Product	Brand	Model No.	Serial No.	FCC ID	Remarks
A	FLASH	SP	MOBILE C31	N/A	N/A	Provided by Lab
B	SWITCH	N/A	N/A	N/A	N/A	Supplied by applicant
C	ADAPTER	CWT	KPL-060F-VI	N/A	N/A	Supplied by applicant
D	Notebook PC	Dell	E5430	1W44PX1	N/A	Provided by Lab
E	Notebook PC	DELL	Latitude E5440	DX8OP32	N/A	Provided by Lab
F	Notebook PC	Dell	Latitude E5470	F4D1S72	N/A	Provided by Lab

ID	Cable Descriptions	Qty.	Length (m)	Shielding (Yes/No)	Cores (Qty.)	Remarks
1	I/O cable	2	0.01	No	0	Supplied by applicant
2	I/O cable	2	0.05	No	0	Supplied by applicant
3	DC power cable	3	0.1	No	0	Supplied by applicant
4	I/O cable	8	0.01	No	0	Supplied by applicant
5	DC power cable	1	1.2	No	1	Supplied by applicant
6	AC power cable	1	1.8	No	0	Provided by Lab
7	DC power cable	1	1.8	No	1	Supplied by applicant
8	AC power cable	1	1.8	No	0	Provided by Lab
9	Micro USB cable	1	1	Yes	0	Supplied by applicant
10	GND cable	1	1.5	No	0	Provided by Lab
11	RJ45 Cable	2	10	Yes	0	Provided by Lab

## 5 Conducted Disturbance at Auxiliary a.c. or d.c. Power Ports

### 5.1 Limits

Frequency (MHz)	Quasi-peak, (dBuV)
0.15 - 0.5	99
0.5 - 30	93

- Notes: 1. The lower limit shall apply at the transition frequencies.  
 2. The limit decreases linearly with the logarithm of the frequency in the range of 0.15 to 0.50 MHz.

### 5.2 Test Instruments

Description & Manufacturer	Model no.	Serial No.	Calibrated Date	Calibrated Until
Test Receiver R&S	ESR3	102414	2021/12/20	2022/12/19
LISN R&S	ENV216	101195	2021/5/25	2022/5/24
LISN R&S	ENV216	101197	2021/6/23	2022/6/22
LISN Schwarzbeck	NNLK8129	8129229	2021/5/20	2022/5/19
DC LISN Schwarzbeck	NNLK 8121	8121-808	2021/4/18	2022/4/17
LISN Schwarzbeck	NNLK 8121	8121-731	2021/4/28	2022/4/27
LISN R&S	ENV216	101196	2021/4/26	2022/4/25
DC LISN R&S	ESH3-Z6	844950/018	2021/7/25	2022/7/24
DC LISN R&S	ESH3-Z6	100219	2021/7/25	2022/7/24
RF Coaxial Cable Commate	5D-FB	Cable-CO10-01	2022/2/9	2023/2/8
Attenuator STI	STI02-2200-10	NO.1	2021/9/15	2022/9/14
50 ohm terminal LYNICS	0900510	E1-011484	2021/5/25	2022/5/24
Isolation Transformer Erika Fiedler	D-65396	017	2021/9/9	2022/9/8
Software BVADT	Cond_V7.3.7.4	NA	NA	NA

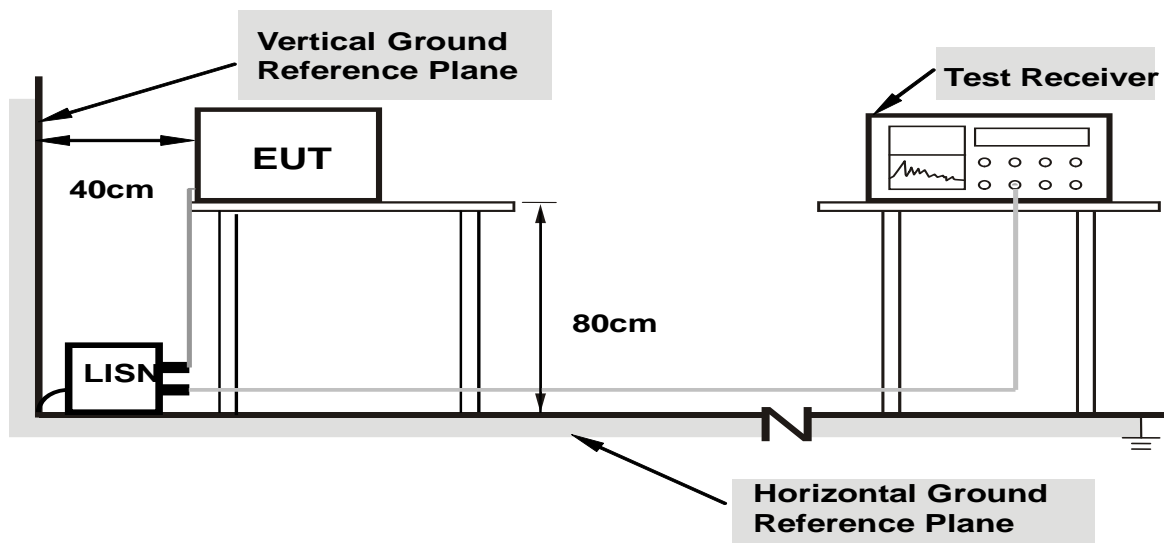
- Note: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.  
 2. The test was performed in Linkou Conduction 10.  
 3. The VCCI Site Registration No. C-11852.  
 4. Tested Date: 2022/4/7



### 5.3 Test Arrangement

- a. The EUT was placed 0.4 meters from the conducting wall of the shielded room with EUT being connected to the power mains through a line impedance stabilization network (LISN). Other support units were connected to the power mains through another LISN. The two LISNs provide 50 Ohm/ 50uH of coupling impedance for the measuring instrument.
- b. Both lines of the power mains connected to the EUT were checked for maximum conducted interference.
- c. The test results of conducted emissions at mains ports are recorded of six worst margins for quasi-peak (mandatory) [and average (if necessary)] values against the limits at frequencies of interest unless the margin is 20 dB or greater.

Note: The resolution bandwidth and video bandwidth of test receiver is 9kHz for quasi-peak detection (QP) and average detection (AV) at frequency 0.15MHz-30MHz.



**Note: Support units were connected to second LISN.**

For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

## 5.4 Test Results

### Mode A

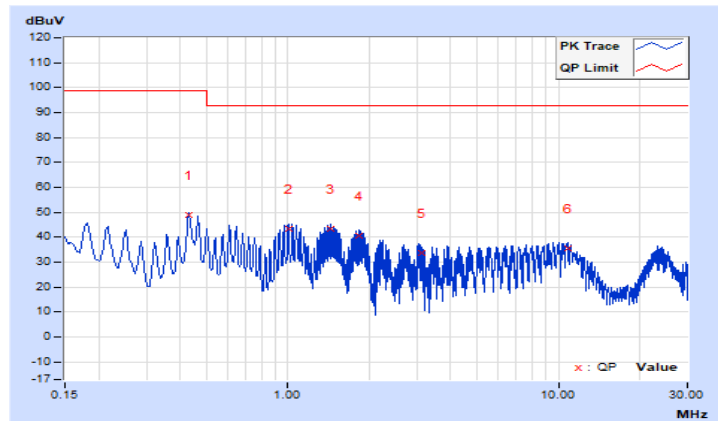
Frequency Range	150 kHz ~ 30 MHz	Detector Function & Resolution Bandwidth	Quasi-Peak (QP), 9kHz
Input Power	230 Vac, 50 Hz	Environmental Conditions	25°C, 75% RH
Tested by	Ed. Lin		

#### Phase Of Power : Line (L)

No	Frequency (MHz)	Correction Factor (dB)	Reading Value (dBuV)	Emission Level (dBuV)	Limit (dBuV)	Margin (dB)
			Q.P.	Q.P.	Q.P.	Q.P.
1	0.43122	9.66	39.09	48.75	99.00	-50.25
2	1.00452	9.70	33.68	43.38	93.00	-49.62
<b>3</b>	<b>1.43473</b>	<b>9.72</b>	<b>33.81</b>	<b>43.53</b>	<b>93.00</b>	<b>-49.47</b>
4	1.82974	9.73	31.10	40.83	93.00	-52.17
5	3.12246	9.76	24.03	33.79	93.00	-59.21
6	10.78828	9.87	25.68	35.55	93.00	-57.45

#### Remarks:

1. Q.P. is abbreviations of quasi-peak individually.
2. The emission levels of other frequencies were very low against the limit.
3. Margin value = Emission level – Limit value
4. Correction factor = Insertion loss + Cable loss
5. Emission Level = Correction Factor + Reading Value

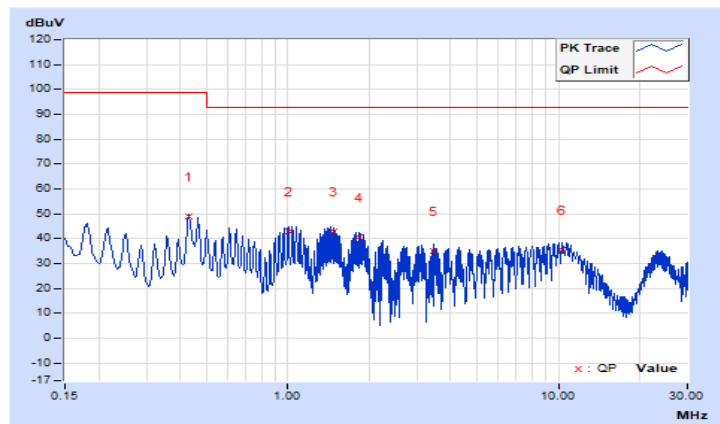


<b>Frequency Range</b>	150 kHz ~ 30 MHz	<b>Detector Function &amp; Resolution Bandwidth</b>	Quasi-Peak (QP), 9kHz
<b>Input Power</b>	230 Vac, 50 Hz	<b>Environmental Conditions</b>	25°C, 75% RH
<b>Tested by</b>	Ed. Lin		

Phase Of Power : Neutral (N)						
No	Frequency (MHz)	Correction Factor (dB)	Reading Value (dBuV)	Emission Level (dBuV)	Limit (dBuV)	Margin (dB)
			Q.P.	Q.P.	Q.P.	Q.P.
1	0.43122	9.66	39.19	48.85	99.00	-50.15
2	1.00452	9.70	33.31	43.01	93.00	-49.99
3	1.46993	9.72	33.14	42.86	93.00	-50.14
4	1.82583	9.73	31.03	40.76	93.00	-52.24
5	3.43925	9.77	25.57	35.34	93.00	-57.66
6	10.35807	9.89	25.82	35.71	93.00	-57.29

**Remarks:**

1. Q.P. is abbreviations of quasi-peak individually.
2. The emission levels of other frequencies were very low against the limit.
3. Margin value = Emission level – Limit value
4. Correction factor = Insertion loss + Cable loss
5. Emission Level = Correction Factor + Reading Value



## 6 Radiated Disturbance up to 1 GHz

### 6.1 Limits

Frequency (MHz)	dBuV/m (at 10m) / quasi-peak
30 - 230	40
230 - 1000	47

- Notes: 1. The lower limit shall apply at the transition frequencies.  
 2. Emission level (dBuV/m) = 20 log Emission level (uV/m).  
 3. All emanations from a class A/B digital device or system, including any network of conductors and apparatus connected thereto, shall not exceed the level of field strengths specified above.

### 6.2 Test Instruments

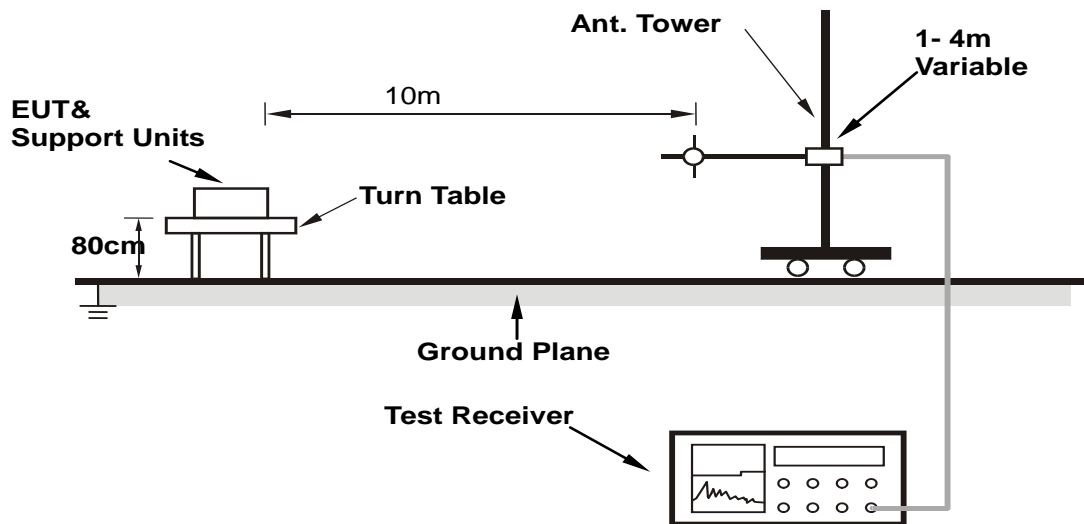
Description & Manufacturer	Model no.	Serial No.	Calibrated Date	Calibrated Until
TEST RECEIVER R&S	ESCS 30	100292	2021/9/1	2022/8/31
TEST RECEIVER R&S	ESCS 30	100276	2021/4/15	2022/4/14
Bi-log Broadband Antenna Schwarzbeck	VULB9168	9168-303	2021/10/29	2022/10/28
Pre_Amplifier HP	8447D	2944A08119	2022/2/17	2023/2/16
Coupling/Dcoupling Network Schwarzbeck	CDNE-M2	00097	2021/5/6	2022/5/5
Coupling/Dcoupling Network Schwarzbeck	CDNE-M3	00091	2021/5/6	2022/5/5
RF Coaxial Cable Pacific	8D-FB	Cable-ST2-01	2021/10/22	2022/10/21
Attenuator Mini-Circuits	UNAT-5+	PAD-ST2-01	2021/10/22	2022/10/21
ADT. Turn Table	TT100	0205	NA	NA
ADT. Tower	AT100	0205	NA	NA
Software BVADT	Radiated_V7.6.15.9.5	NA	NA	NA

- Note: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.  
 2. The test was performed in Linkou Open Site 2. The test site validated date: 2021/07/30(NSA)  
 3. The VCCI Site Registration No. R-10237.  
 4. Tested Date: 2022/4/6

### 6.3 Test Arrangement

- The EUT was placed on the top of a rotating table 0.8 meters above the ground at an accredited test facility. The table was rotated 360 degrees to determine the position of the highest radiation.
- The EUT was set 10 meters away from the interference-receiving antenna, which was mounted on the top of a variable-height antenna tower.
- The antenna is a broadband antenna, and its height is varied from one meter to four meters above the ground to determine the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to heights from 1 meter to 4 meters and the rotatable table was turned from 0 degrees to 360 degrees to find the maximum reading.
- The test-receiver system was set to quasi-peak detect function and specified bandwidth with maximum hold mode when the test frequency is up to 1 GHz.

Note: The resolution bandwidth and video bandwidth of test receiver/spectrum analyzer is 120kHz for quasi-peak detection (QP) at frequency up to 1GHz.



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

## 6.4 Test Results

### Mode A

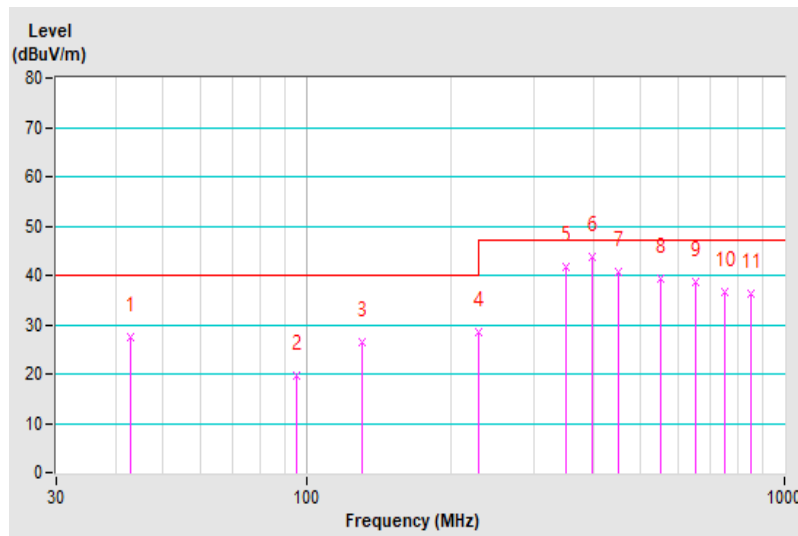
Frequency Range	30MHz ~ 1GHz	Detector Function & Resolution Bandwidth	Quasi-Peak (QP), 120kHz
Input Power	230 Vac, 50 Hz	Environmental Conditions	26°C, 60% RH
Tested By	Vincent Lin		

#### Antenna Polarity & Test Distance : Horizontal at 10 m

No	Frequency (MHz)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (m)	Table Angle (Degree)	Raw Value (dBuV)	Correction Factor (dB/m)
1	42.91	27.40 QP	40.00	-12.60	4.00 H	350	37.83	-10.43
2	95.45	19.56 QP	40.00	-20.44	4.00 H	76	34.84	-15.28
3	131.25	26.29 QP	40.00	-13.71	4.00 H	37	36.99	-10.70
4	228.90	28.48 QP	40.00	-11.52	4.00 H	243	40.20	-11.72
5	349.85	41.64 QP	47.00	-5.36	3.85 H	272	48.37	-6.73
<b>6</b>	<b>396.18</b>	<b>43.63 QP</b>	<b>47.00</b>	<b>-3.37</b>	<b>4.00 H</b>	<b>62</b>	<b>49.12</b>	<b>-5.49</b>
7	449.99	40.70 QP	47.00	-6.30	3.23 H	150	44.82	-4.12
8	550.00	39.38 QP	47.00	-7.62	2.23 H	152	41.54	-2.16
9	650.00	38.67 QP	47.00	-8.33	1.91 H	210	38.30	0.37
10	750.00	36.69 QP	47.00	-10.31	1.92 H	199	34.03	2.66
11	849.98	36.19 QP	47.00	-10.81	1.00 H	278	30.75	5.44

#### Remarks:

1. Emission Level(dBuV/m) = Raw Value(dBuV) + Correction Factor(dB/m)
2. Correction Factor(dB/m) = Antenna Factor (dB/m) + Cable Factor (dB) – Pre-Amplifier Factor (dB)
3. The other emission levels were very low against the limit.
4. Margin value = Emission level – Limit value

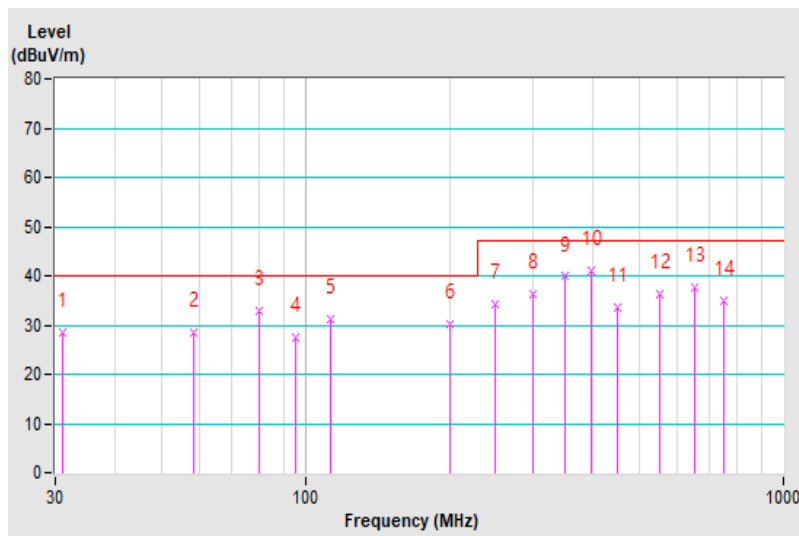


<b>Frequency Range</b>	30MHz ~ 1GHz	<b>Detector Function &amp; Resolution Bandwidth</b>	Quasi-Peak (QP), 120kHz
<b>Input Power</b>	230 Vac, 50 Hz	<b>Environmental Conditions</b>	26°C, 60% RH
<b>Tested By</b>	Vincent Lin		

Antenna Polarity & Test Distance : Vertical at 10 m								
No	Frequency (MHz)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (m)	Table Angle (Degree)	Raw Value (dBuV)	Correction Factor (dB/m)
1	31.02	28.33 QP	40.00	-11.67	1.00 V	87	40.36	-12.03
2	58.42	28.60 QP	40.00	-11.40	1.00 V	31	39.43	-10.83
3	80.17	32.76 QP	40.00	-7.24	1.53 V	154	47.96	-15.20
4	95.60	27.45 QP	40.00	-12.55	1.00 V	259	42.71	-15.26
5	113.19	31.22 QP	40.00	-8.78	1.00 V	323	43.69	-12.47
6	200.11	30.02 QP	40.00	-9.98	1.00 V	211	42.57	-12.55
7	250.00	34.18 QP	47.00	-12.82	1.90 V	294	44.05	-9.87
8	300.00	36.21 QP	47.00	-10.79	1.00 V	328	43.97	-7.76
9	350.00	39.83 QP	47.00	-7.17	1.74 V	280	46.56	-6.73
10	396.11	41.09 QP	47.00	-5.91	1.39 V	25	46.58	-5.49
11	450.00	33.69 QP	47.00	-13.31	3.17 V	314	37.81	-4.12
12	550.00	36.18 QP	47.00	-10.82	2.35 V	121	38.34	-2.16
13	649.99	37.47 QP	47.00	-9.53	2.56 V	223	37.10	0.37
14	749.99	34.91 QP	47.00	-12.09	2.82 V	40	32.25	2.66

**Remarks:**

1. Emission Level(dBuV/m) = Raw Value(dBuV) + Correction Factor(dB/m)
2. Correction Factor(dB/m) = Antenna Factor (dB/m) + Cable Factor (dB) – Pre-Amplifier Factor (dB)
3. The other emission levels were very low against the limit.
4. Margin value = Emission level – Limit value



## 7 Radiated Disturbance above 1 GHz

### 7.1 Limits

Frequency (GHz)	dBuV/m (at 3m)	
	Average	Peak
1 to 3	56	76
3 to 6	60	80

- Notes: 1. The lower limit shall apply at the transition frequencies.  
 2. Emission level (dBuV/m) = 20 log Emission level (uV/m).  
 3. All emanations from a class A/B digital device or system, including any network of conductors and apparatus connected thereto, shall not exceed the level of field strengths specified above.

#### Frequency Range (For unintentional radiators)

Highest frequency generated or used in the EUT or on which the EUT operates or tunes (MHz)	Upper frequency of measurement range (MHz)
Below 108	1000
108-500	2000
500-1000	5000
Above 1000	Up to 5 times of the highest frequency or 6 GHz, whichever is less



## 7.2 Test Instruments

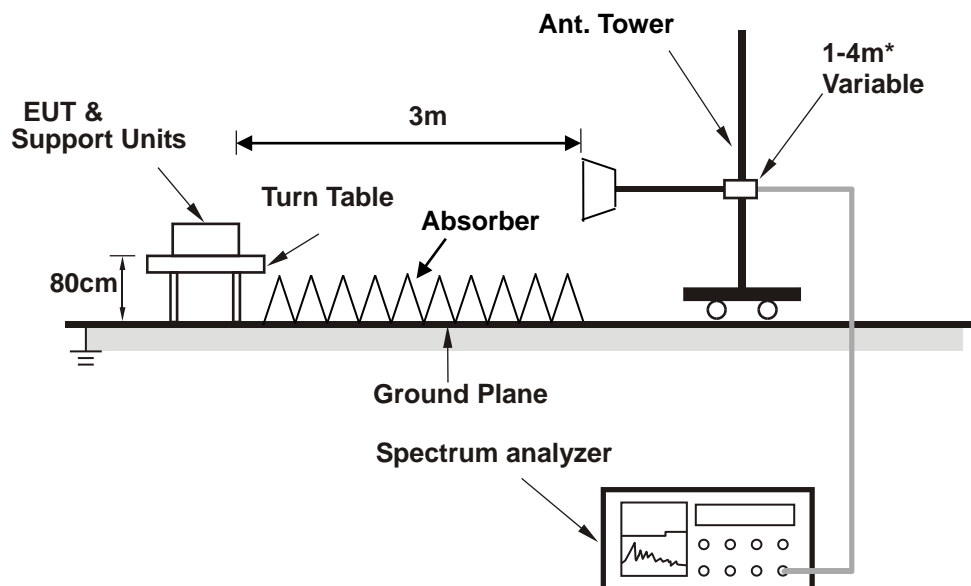
Description & Manufacturer	Model no.	Serial No.	Calibrated Date	Calibrated Until
Spectrum Analyzer Agilent	E4446A	MY51100009	2021/6/29	2022/6/28
Spectrum Keysight	N9020B	MY60110438	2021/12/8	2022/12/7
Test Receiver Agilent	N9038A	MY51210137	2021/6/16	2022/6/15
Pre-amplifier HP	8449B	3008A01292	2022/2/17	2023/2/16
Pre_Amplifier EMCI	EMC0126545	980076	2022/2/17	2023/2/16
Horn Antenna ETS-Lindgren	3117-PA	00215857	2021/11/14	2022/11/13
Horn Antenna EMCO	3115	6714	2021/11/14	2022/11/13
Pre_Amplifier EMCI	EMC184045B	980235	2022/2/17	2023/2/16
Horn Antenna Schwarzbeck	BBHA 9170	212	2021/10/13	2022/10/12
RF Coaxial Cable Rosnol	K1K50-UP0279-K1K 50-3000	Cable-CH10(3m)-04	2021/7/8	2022/7/7
RF Coaxial Cable WOKEN	WC01	Cable-CH10-03	2021/7/8	2022/7/7
Attenuator Mini-Circuits	BW-N4W5+	PAD-CH10-02	2021/7/8	2022/7/7
Attenuator Mini-Circuits	BW-K3-2W44+	PAD-CH7-03	2021/7/8	2022/7/7
BandPass Filter MICRO-TRONICS	BRM17690	005	2021/5/28	2022/5/27
Notch filter MICRO-TRONICS	BRC50703-01	010	2021/5/28	2022/5/27
Fix tool for Boresight antenna tower BV	BAF-01	9	NA	NA
Turn Table & Tower Max Full	MF7802	MF780208216	NA	NA
Software BVADT	Radiated_V8.7.08	NA	NA	NA

- Note:
1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.
  2. The test was performed in Linkou 966 Chamber3(CH10)
  3. The VCCI Site Registration No. G-10427
  4. Tested Date: 2022/4/7

### 7.3 Test Arrangement

- The EUT was placed on the top of a rotating table 0.8 meters above the ground at an accredited chamber room. The table was rotated 360 degrees to determine the position of the highest radiation.
- The EUT was set 3 meters away from the interference-receiving antenna, which was mounted on the top of a variable-height antenna tower.
- The height of antenna can be varied from one meter to four meters, the height of adjustment depends on the EUT height and the antenna 3dB beamwidth both, to detect the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to heights and the rotatable table was turned from 0 degrees to 360 degrees to find the maximum reading.
- The spectrum analyzer system was set to peak and average detect function and specified bandwidth with maximum hold mode when the test frequency is above 1 GHz.

Note: The resolution bandwidth of test receiver/spectrum analyzer is 1MHz and video bandwidth is 3MHz for Peak detection (PK) at frequency above 1GHz. The resolution bandwidth of test receiver/spectrum analyzer is 1 MHz for Average detection (AV) at frequency above 1GHz.



\* :depends on the EUT height and the antenna 3dB beamwidth both.

For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

## 7.4 Test Results

### Mode A

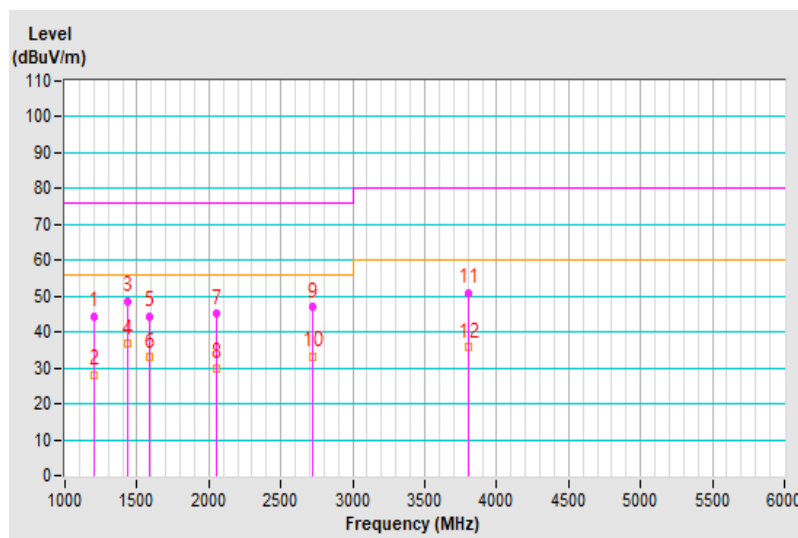
Frequency Range	1GHz ~ 5GHz	Detector Function & Resolution Bandwidth	Peak (PK) / Average (AV), 1MHz
Input Power	230 Vac, 50 Hz	Environmental Conditions	20°C, 70% RH
Tested By	Bob Lin		

#### Antenna Polarity & Test Distance : Horizontal at 3 m

No	Frequency (MHz)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (m)	Table Angle (Degree)	Raw Value (dBuV)	Correction Factor (dB/m)
1	1198.39	44.37 PK	76.00	-31.63	2.33 H	65	48.91	-4.54
2	1198.39	27.98 AV	56.00	-28.02	2.33 H	65	32.52	-4.54
3	1439.92	48.50 PK	76.00	-27.50	1.08 H	174	52.21	-3.71
4	1439.92	36.68 AV	56.00	-19.32	1.08 H	174	40.39	-3.71
5	1584.18	44.30 PK	76.00	-31.70	1.79 H	290	47.57	-3.27
6	1584.18	32.87 AV	56.00	-23.13	1.79 H	290	36.14	-3.27
7	2057.26	45.04 PK	76.00	-30.96	2.56 H	107	46.53	-1.49
8	2057.26	29.82 AV	56.00	-26.18	2.56 H	107	31.31	-1.49
9	2715.91	46.85 PK	76.00	-29.15	3.13 H	1	46.73	0.12
10	2715.91	33.08 AV	56.00	-22.92	2.13 H	1	32.96	0.12
11	3800.63	50.77 PK	80.00	-29.23	1.98 H	348	46.04	4.73
12	3800.63	35.67 AV	60.00	-24.33	1.98 H	348	30.94	4.73

#### Remarks:

1. Emission Level(dBuV/m) = Raw Value(dBuV) + Correction Factor(dB/m)
2. Correction Factor(dB/m) = Antenna Factor (dB/m) + Cable Factor (dB) – Pre-Amplifier Factor (dB)
3. The other emission levels were very low against the limit.
4. Margin value = Emission level – Limit value

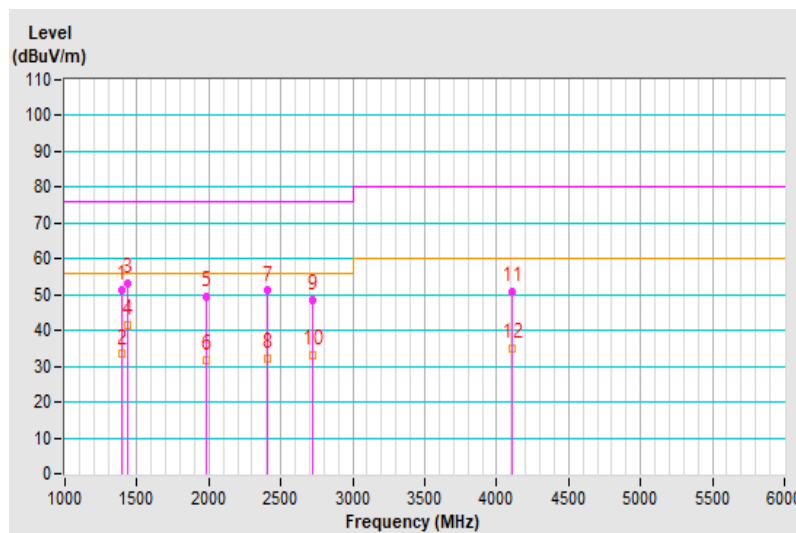


<b>Frequency Range</b>	1GHz ~ 5GHz	<b>Detector Function &amp; Resolution Bandwidth</b>	Peak (PK) / Average (AV), 1MHz
<b>Input Power</b>	230 Vac, 50 Hz	<b>Environmental Conditions</b>	20°C, 70% RH
<b>Tested By</b>	Bob Lin		

Antenna Polarity & Test Distance : Vertical at 3 m								
No	Frequency (MHz)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (m)	Table Angle (Degree)	Raw Value (dBuV)	Correction Factor (dB/m)
1	1397.39	51.40 PK	76.00	-24.60	1.82 V	356	55.29	-3.89
2	1397.39	33.34 AV	56.00	-22.66	1.82 V	356	37.23	-3.89
3	1440.02	53.31 PK	76.00	-22.69	1.00 V	228	57.02	-3.71
<b>4</b>	<b>1440.02</b>	<b>41.38 AV</b>	<b>56.00</b>	<b>-14.62</b>	<b>1.00 V</b>	<b>228</b>	<b>45.09</b>	<b>-3.71</b>
5	1980.23	49.42 PK	76.00	-26.58	1.22 V	326	51.49	-2.07
6	1980.23	31.67 AV	56.00	-24.33	1.22 V	326	33.74	-2.07
7	2402.04	51.04 PK	76.00	-24.96	2.01 V	1	51.58	-0.54
8	2402.04	32.14 AV	56.00	-23.86	2.01 V	1	32.68	-0.54
9	2717.35	48.56 PK	76.00	-27.44	1.19 V	197	48.44	0.12
10	2717.35	33.19 AV	56.00	-22.81	1.19 V	197	33.07	0.12
11	4106.50	50.94 PK	80.00	-29.06	1.13 V	111	46.31	4.63
12	4106.50	35.11 AV	60.00	-24.89	1.13 V	111	30.48	4.63

**Remarks:**

1. Emission Level(dBuV/m) = Raw Value(dBuV) + Correction Factor(dB/m)
2. Correction Factor(dB/m) = Antenna Factor (dB/m) + Cable Factor (dB) – Pre-Amplifier Factor (dB)
3. The other emission levels were very low against the limit.
4. Margin value = Emission level – Limit value



## 8 Harmonics Current Measurement

### 8.1 Limits

Limits for Class A equipment		Limits for Class D equipment		
Harmonic Order n	Max. permissible harmonics current A	Harmonic Order n	Max. permissible harmonics current per watt mA/W	Max. permissible harmonics current A
Odd harmonics		Odd Harmonics only		
3	2.30	3	3.4	2.30
5	1.14	5	1.9	1.14
7	0.77	7	1.0	0.77
9	0.40	9	0.5	0.40
11	0.33	11	0.35	0.33
13	0.21	13	0.30	0.21
$15 \leq n \leq 39$	$0.15 \times 15/n$	$15 \leq n \leq 39$	$3.85/n$	$0.15 \times 15/n$
Even harmonics				
2	1.08			
4	0.43			
6	0.30			
$8 \leq n \leq 40$	$0.23 \times 8/n$			

Notes: 1. Class A and Class D are classified according to section 5 of EN 61000-3-2.

2. According to section 7 of EN 61000-3-2, the above limits for all equipment except for lighting equipment having an active input power > 75 W and no limits apply for equipment with an active input power up to and including 75 W.

### 8.2 Classification of Equipment

Class A	Class B	Class C	Class D
Balanced three-phase equipment; Household appliances excluding equipment as Class D; Tools excluding portable tools; Dimmers for incandescent lamps; Audio equipment; Equipment not specified in one of the three other classes.	Portable tools; Arc welding equipment which is not professional equipment.	Lighting equipment.	Equipment having a specified power less than or equal to 600 W of the following types: Personal computers and personal computer monitors; Television receivers; Refrigerators and freezers having one or more variable-speed drives to control compressor motor(s).

### 8.3 Test Instruments

Description & Manufacturer	Model No.	Serial No.	Calibrated Date	Calibrated Until
Harmonics and Flicker Analyzer TESEQ	PROFLINE 2105	1632A00983&1639A01863	2021/6/8	2022/6/7
Software	CTS 4	NA	NA	NA

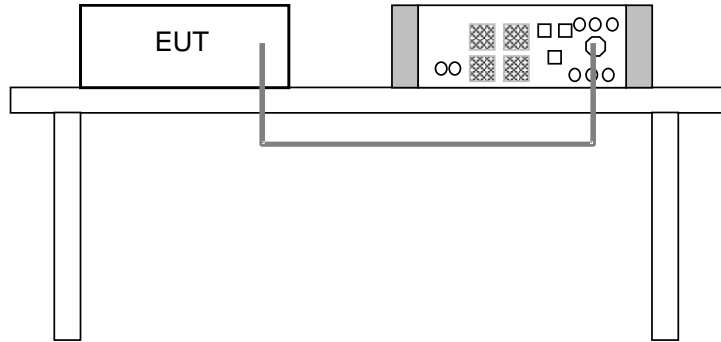
Note: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

2. The test was performed in EMS Room No. 1.

3. Tested Date: 2022/3/31

### 8.4 Test Arrangement

- a. The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the maximum harmonic components under normal operating conditions for each successive harmonic component in turn.
- b. The correspondent test program of test instrument to measure the current harmonics emanated from EUT is chosen. The measure time shall be not less than the time necessary for the EUT to be exercised.



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

### 8.5 Test Results

#### Mode A

<b>Test Duration</b>	5 min	<b>Fundamental Voltage / Ampere</b>	230.68 Vrms / 0.090 Arms
<b>Power Consumption</b>	5.3 W	<b>Power Frequency</b>	50 Hz
<b>Power Factor</b>	0.271	<b>Environmental Conditions</b>	18°C, 78% RH
<b>Tested By</b>	Bernie Lu		

- Notes:
1. Limits are not specified for equipment with a rated power of 75W or less (other than lighting equipment).
  2. According to EN 61000-3-2 the manufacturer shall specify the power of the apparatus. This value shall be used for establishing limits. The specified power shall be within +/-10% of the measured power.

## 9 Voltage Fluctuations and Flicker Measurement

### 9.1 Limits

Test item	Limit	Note
$P_{st}$	1.0	$P_{st}$ : short-term flicker severity.
$P_{lt}$	0.65	$P_{lt}$ : long-term flicker severity.
$T_{max}$ (ms)	500	$T_{max}$ : maximum time duration during the observation period that the voltage deviation $d(t)$ exceeds the limit for $d_c$ .
$d_{max}$ (%)	4	$d_{max}$ : maximum absolute voltage change during an observation period.
$d_c$ (%)	3.3	$d_c$ : maximum steady state voltage change during an observation period.

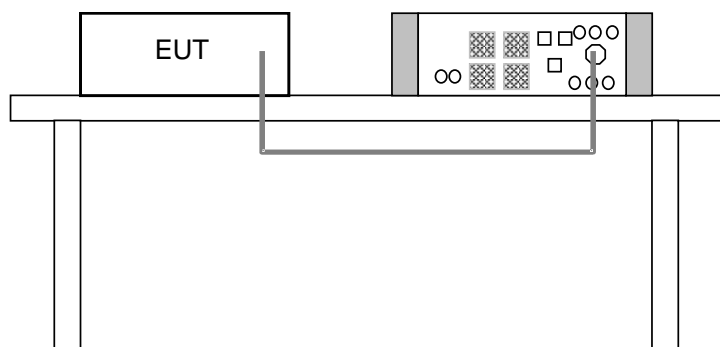
### 9.2 Test Instruments

Description & Manufacturer	Model No.	Serial No.	Calibrated Date	Calibrated Until
Harmonics and Flicker Analyzer TESEQ	PROFLINE 2105	1632A00983&1639A 01863	2021/6/8	2022/6/7
Software	CTS 4	NA	NA	NA

- Note:
1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.
  2. The test was performed in EMS Room No. 1.
  3. Tested Date: 2022/3/31

### 9.3 Test Arrangement

- a. The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the most unfavorable sequence of voltage changes under normal operating conditions.
- b. During the flick measurement, the measure time shall include that part of whole operation cycle in which the EUT produce the most unfavorable sequence of voltage changes. The observation period for short-term flicker indicator is 10 minutes and the observation period for long-term flicker indicator is 2 hours.



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

## 9.4 Test Results

### Mode A

<b>Observation (Tp)</b>	10 min		
<b>Input Power</b>	230 Vac, 50 Hz	<b>Environmental Conditions</b>	18°C, 78% RH
<b>Tested By</b>	Bernie Lu		

Test Parameter	Measurement Value	Limit	Remarks
P <sub>st</sub>	0.277	1.00	Pass
P <sub>lt</sub>	0.121	0.65	Pass
T <sub>max</sub> (ms)	0.000	500	Pass
d <sub>max</sub> (%)	0.000	4.00	Pass
d <sub>c</sub> (%)	0.000	3.30	Pass

#### Notes:

1. P<sub>st</sub> means short-term flicker indicator.
2. P<sub>lt</sub> means long-term flicker indicator.
3. T<sub>max</sub> means accumulated time value of d(t) with a deviation exceeding 3.3 %.
4. d<sub>max</sub> means maximum relative voltage change.
5. d<sub>c</sub> means maximum relative steady-state voltage change.



## 10 Electrostatic Discharge Immunity Test (ESD)

### 10.1 Test Specification

<b>Basic Standard:</b>	EN 61000-4-2
<b>Discharge Impedance:</b>	330 ohm / 150 pF
<b>Discharge Voltage:</b>	Air Discharge: $\pm 2$ , $\pm 4$ , $\pm 8$ kV (Direct) Contact Discharge: $\pm 2$ , $\pm 4$ , $\pm 6$ kV (Indirect & Direct )
<b>Number of Discharge:</b>	Minimum 20 times at each test point
<b>Discharge Mode:</b>	Single Discharge
<b>Discharge Period:</b>	1-second minimum

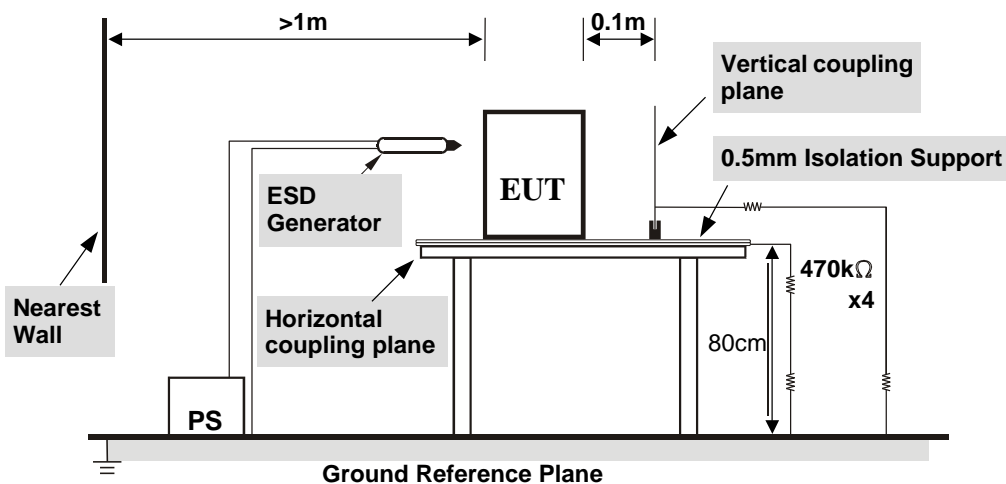
### 10.2 Test Instruments

Description & Manufacturer	Model No.	Serial No.	Calibrated Date	Calibrated Until
ESD Simulator KeyTek	MZ15/EC	0504259	2021/11/10	2022/11/9
ESD Simulator KeyTek	MZ-15/EC	0401299	2021/10/7	2022/10/6
ESD Simulator TESEQ	NSG 438	1364	2021/12/16	2022/12/15
Electronic Discharge Simulator Noiseken	ESS-2000	ESS0382041	2021/10/7	2022/10/6
ESD Generator EM Test	Dito//DM-150/330//DM-150/3 30-rfci	P1315117252/P1317117852	2021/7/9	2022/7/8

- Note:
1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.
  2. The test was performed in Linkou ESD 01.
  3. Tested Date: 2022/3/31

### 10.3 Test Arrangement

- a. Electrostatic discharges were applied only to those points and surfaces of the EUT that are accessible to users during normal operation.
- b. The test was performed with at least ten single discharges on the pre-selected points in the most sensitive polarity.
- c. The time interval between two successive single discharges was at least 1 second.
- d. The ESD generator was held perpendicularly to the surface to which the discharge was applied and the return cable was at least 0.2 meters from the EUT.
- e. Contact discharges were applied to the non-insulating coating, with the pointed tip of the generator penetrating the coating and contacting the conducting substrate.
- f. Air discharges were applied with the round discharge tip of the discharge electrode approaching the EUT as fast as possible (without causing mechanical damage) to touch the EUT. After each discharge, the ESD generator was removed from the EUT and re-triggered for a new single discharge. The test was repeated until all discharges were complete.
- g. At least ten single discharges (in the most sensitive polarity) were applied to the **Horizontal Coupling Plane** at points on each side of the EUT. The ESD generator was positioned at a distance of 0.1 meters from the EUT with the discharge electrode touching the **HCP**.
- h. At least ten single discharges (in the most sensitive polarity) were applied to the center of one vertical edge of the **Vertical Coupling Plane** in sufficiently different positions that the four faces of the EUT were completely illuminated. The **VCP** (dimensions 0.5m x 0.5m) was placed vertically to and 0.1 meters from the EUT.



#### TABLE-TOP EQUIPMENT

The configuration consisted of a wooden table 0.8 meters high standing on the **Ground Reference Plane**. The **GRP** consisted of a sheet of aluminum at least 0.25mm thick, and 2.5 meters square connected to the protective grounding system. A **Horizontal Coupling Plane** (1.6m x 0.8m) was placed on the table and attached to the **GRP** by means of a cable with 940kΩ total impedance. The equipment under test, was installed in a representative system as described in section 7 of EN 61000-4-2, and its cables were placed on the **HCP** and isolated by an insulating support of 0.5mm thickness. A distance of 1-meter minimum was provided between the EUT and the walls of the laboratory and any other metallic structure.

For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

## 10.4 Test Results

### Mode A

Input Power	AC 230V / 50Hz	Environmental conditions	23 °C, 36 % RH 1010 mbar
Tested by	Bernie Lu		

#### Test Results of Direct Application

Discharge Level (kV)	Polarity (+/-)	Test Point	Contact Discharge	Air Discharge	Performance Criterion
2	+/-	1-3	Note 1	---	A
4, 6	+/-	1-3	Note 2	---	B
2, 4, 8	+/-	8	---	Note 1	A
2, 4	+/-	4-7	---	Note 1	A
8	+/-	4-7	---	Note 2	B

Description of test points of direct application: Please refer to following page for representative mark only.

#### Test Results of Indirect Application

Discharge Level (kV)	Polarity (+/-)	Test Point	Horizontal Coupling Plane	Vertical Coupling Plane	Performance Criterion
2, 4, 6	+/-	Four Sides	Note 1	Note 1	A

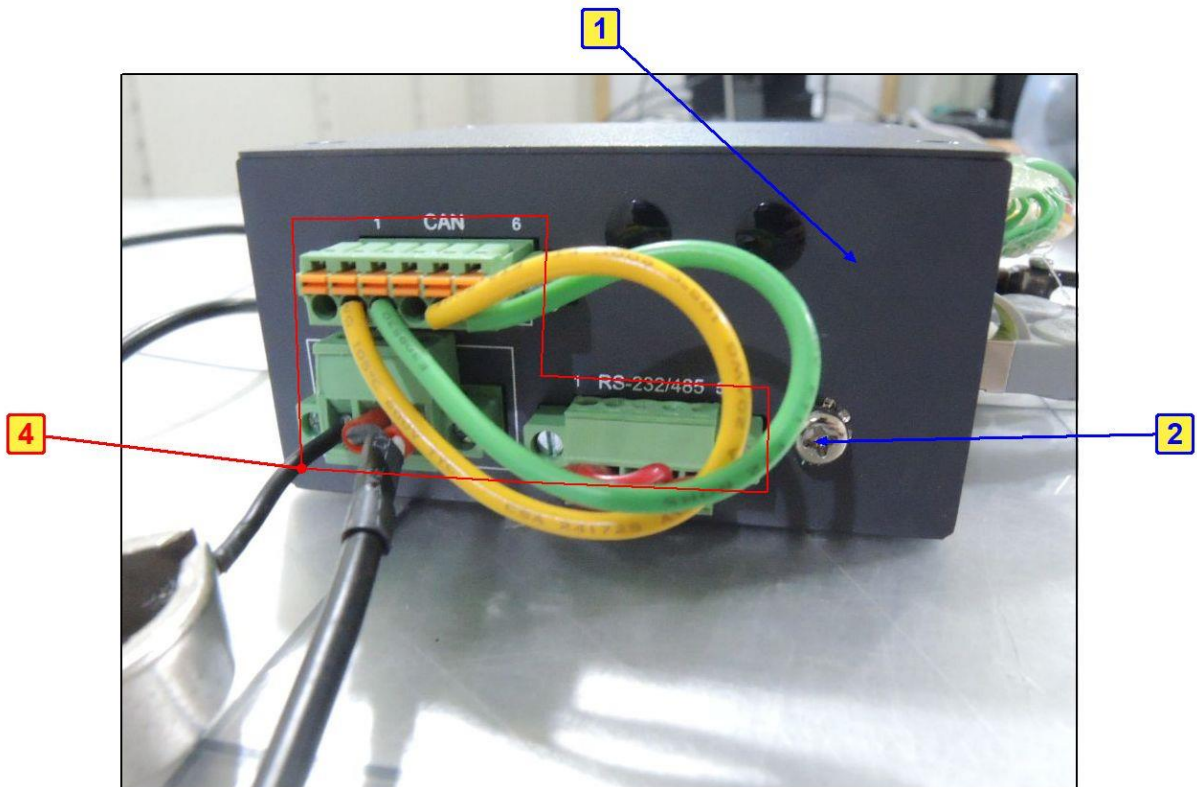
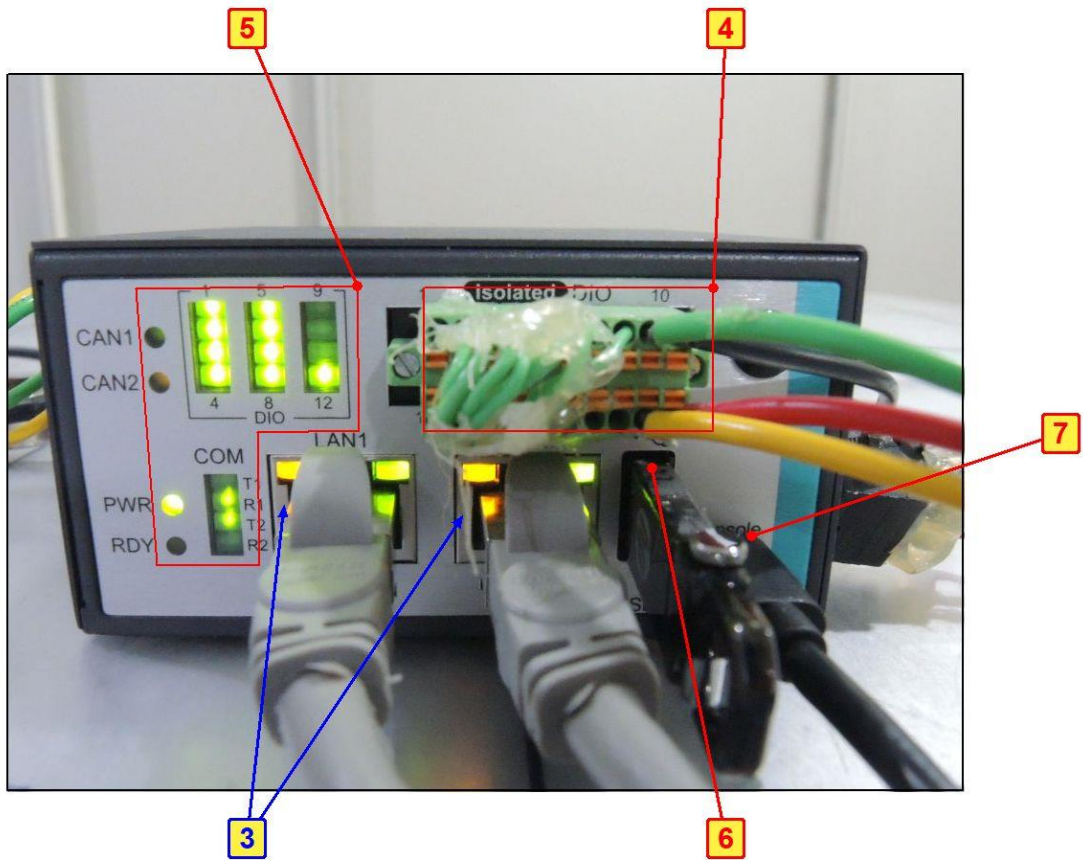
Description of test points of indirect application:

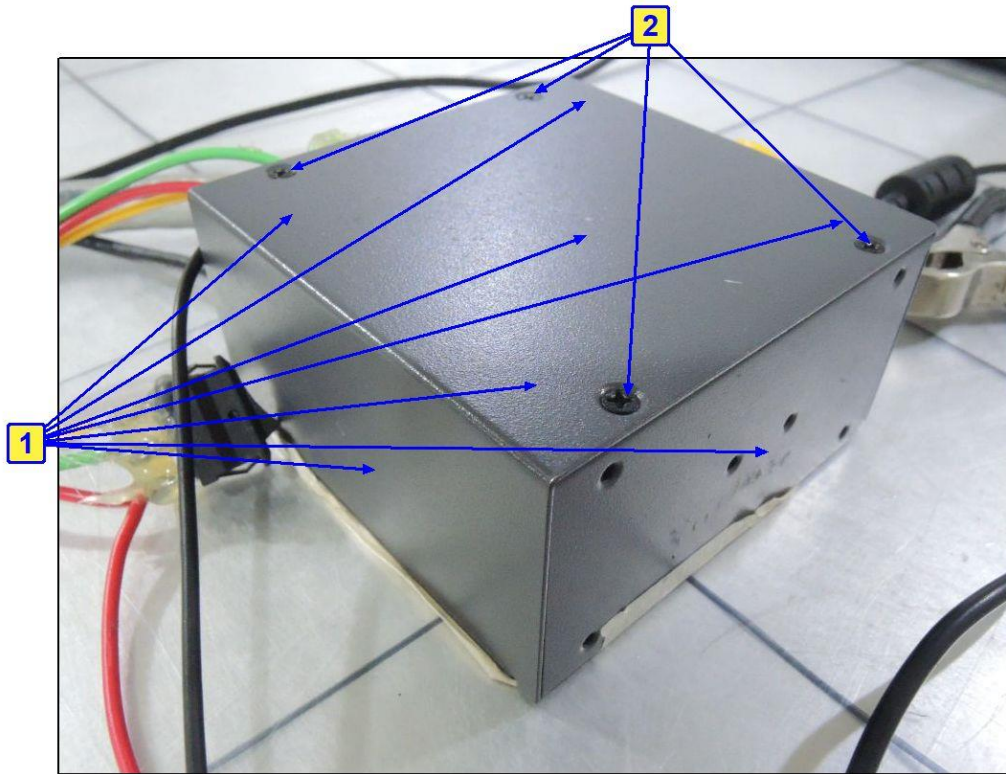
1. Front side                      2. Rear side                      3. Right side                      4. Left side

- Note: 1. The EUT is operated normal during the test.  
2. The R/W of EUT delay 1-3sec, but auto recovered after the test.

Description of Test Points

DESCRIPTION OF TEST POINT





## 11 Radio-frequency Electromagnetic Field Immunity Test (RS)

### 11.1 Test Specification

Basic Standard:	EN 61000-4-3
	80-800 MHz, 20V/m <sup>1</sup>
	800-1000 MHz, 20V/m
Frequency Range, Field Strength:	1400-2000 MHz, 10V/m
	2000-2700 MHz, 5V/m
	5100-6000 MHz, 3V/m
Modulation:	1kHz Sine Wave, 80%, AM Modulation
Frequency Step:	1 % of preceding frequency value
Polarity of Antenna:	Horizontal and Vertical
Antenna Height:	1.5m
Dwell Time:	3 seconds

Note 1: This limit applies to equipment mounted in the passenger compartments, drivers cab or external to the rolling stock (roof, underframe). For equipment mounted in all other areas a severity level of 10 V/m may be used.

## 11.2 Test Instruments

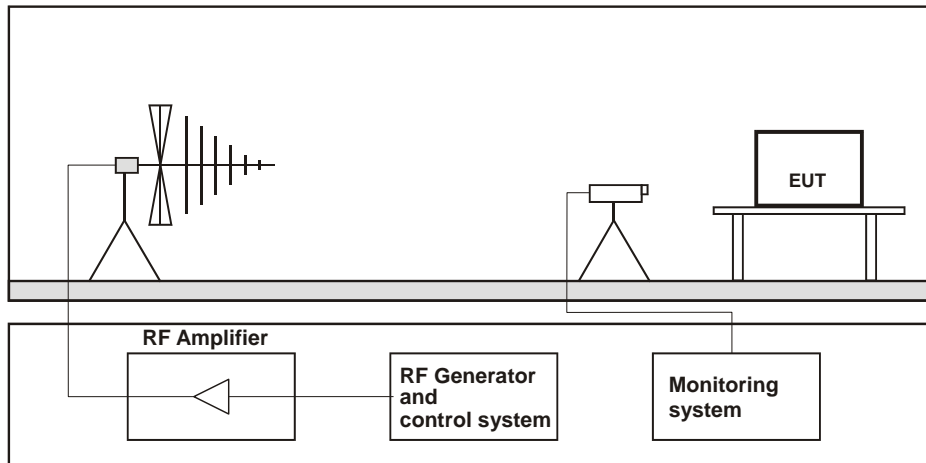
Description & Manufacturer	Model no.	Serial No.	Calibrated Date	Calibrated Until
Signal Generator Agilent	E8257D	MY48050465	2021/6/22	2022/6/21
Amplifier BONN	BSA 0125-800	1912556	NA	NA
Amplifier TESTQ	CBA 1G-275	T44344	NA	NA
Power Amplifier AR	35S4G8AM4	0326094	NA	NA
Power Amplifier AR	100S1G4M3	0329249	NA	NA
Controller AR	SC1000M3	305910	NA	NA
RF Power meter BOONTON	4232A	10180	2021/5/24	2022/5/23
Power sensor BOONTON	51011-EMC	34152	2021/5/24	2022/5/23
Power sensor BOONTON	51011-EMC	34153	2021/5/24	2022/5/23
Log-Periodic Antenna AR	AT6080	0329465	NA	NA
BiconiLog Antenna EMCO	3141	1001	NA	NA
High Gain Horn Antenna AR	AT4010	0329800	NA	NA
LOG ANTENNA Schwarzbeck	Schwarzbeck Stlp 9149	9149-260	NA	NA
CHANCE MOST Full Anechoic Chamber (9x5x3m)	Chance Most	RS-002	2022/2/3	2023/2/2
Software BVADT	RS_V7.6	NA	NA	NA
Audio analyzer R&S	UPV	104565	2021/5/18	2022/5/17
Ear Simulator Telephonometry B&K	4185	2553594	NA	NA
Pressure-field Microphone B&K	4192	3190854	2021/12/20	2022/12/19
Two channel microphone conditioning amplifier B&K	2690 A OS2	2645274	2021/5/16	2022/5/15
POWER AMPLIFIER B&K	2716C	2610979	NA	NA
Mouth Simulator B&K	4227	2630632	NA	NA
Software	ABMS_ V7.4.3	NA	NA	NA

- Note:
1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.
  2. The test was performed in RS Room No.2.
  3. Tested Date: 2022/4/2

### 11.3 Test Arrangement

The test procedure was in accordance with EN 61000-4-3.

- a. The testing was performed in a fully anechoic chamber.
- b. The frequency ranges and field strength levels are 80-800 MHz, 20V/m, 800-1000 MHz, 20V/m, 1400-2000 MHz, 10V/m, 2000-2700 MHz, 5V/m and 5100-6000 MHz, 3V/m with the signal 80% amplitude modulated with a 1kHz sine wave.
- c. The test was performed with the EUT exposed to both vertically and horizontally polarized fields on each of the four sides.



#### Table-top Equipment

The EUT installed in a representative system as described in section 7 of EN 61000-4-3 was placed on a non-conductive table 0.8 meters in height. The system under test was connected to the power and signal wire according to relevant installation instructions.

For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

### 11.4 Test Results

#### Mode A

Input Power	AC 230V / 50Hz	Environmental conditions	20 °C, 79 % RH
Tested by	Bernie Lu		

Frequency (MHz)	Polarity	Azimuth(°)	Applied Field Strength		Observation	Performance Criterion
			(V/m)	Modulation		
80 - 800	V&H	0, 90, 180, 270	20	80% AM (1kHz)	Note	A
800 - 1000	V&H	0, 90, 180, 270	20	80% AM (1kHz)	Note	A
1400 - 2000	V&H	0, 90, 180, 270	10	80% AM (1kHz)	Note	A
2000 - 2700	V&H	0, 90, 180, 270	5	80% AM (1kHz)	Note	A
5100 - 6000	V&H	0, 90, 180, 270	3	80% AM (1kHz)	Note	A

Note: The EUT is operated normal during the test.



## 12 Electrical Fast Transient/Burst Immunity Test (EFT)

### 12.1 Test Specification

Basic Standard:	EN 61000-4-4
Test Voltage:	Signal & communication, process measurement & control ports: $\pm 2\text{kV}$ , Capacitive clamp Battery referenced ports (except at the output of energy sources), Auxiliary a.c. power input ports (rated voltage $\leq 400\text{ Vrms}$ ): $\pm 2\text{kV}$
Impulse Repetition Frequency:	5kHz
Impulse Wave Shape:	5/50 ( $T_r/T_h$ ) ns
Burst Duration:	15 ms
Burst Period:	300 ms
Test Duration:	1 min.

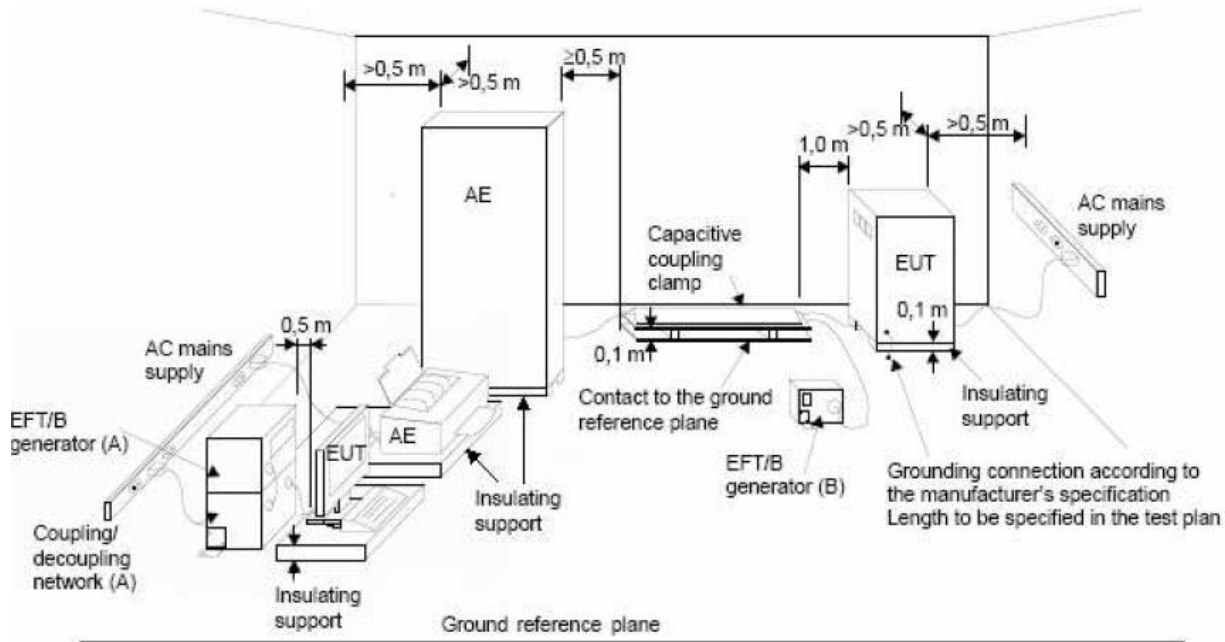
### 12.2 Test Instruments

Description & Manufacturer	Model No.	Serial No.	Calibrated Date	Calibrated Until
Burst generator Haefely	PEFT 4010	154954	2021/4/7	2022/4/6

- Note:
1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.
  2. The test was performed in EFT Room
  3. Tested Date: 2022/3/23

### 12.3 Test Arrangement

- Both positive and negative polarity discharges were applied.
- The distance between any coupling devices and the EUT should be 0.5 m for table-top equipment testing, and 1.0 m for floor standing equipment.
- The duration time of each test sequential was 1 minute.
- The transient/burst waveform was in accordance with EN 61000-4-4, 5/50 ns.



**NOTE:**

- location for supply line coupling
- location for signal lines coupling

For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

## 12.4 Test Results

### Mode A

Input Power	AC 230V / 50Hz	Environmental conditions	21 °C, 73 % RH
Tested by	Chiming Li		

Battery referenced ports (except at the output of energy sources),  
Auxiliary a.c. power input ports (rated voltage  $\leq$  400 Vrms)

Voltage (kV)	Test Point	Polarity (+/-)	Observation	Performance Criterion
2	L	+/-	Note	A
2	N	+/-	Note	A
2	PE	+/-	Note	A
2	L-N-PE	+/-	Note	A

Signal & communication, process measurement & control ports

Voltage (kV)	Test Point	Polarity (+/-)	Observation	Performance Criterion
2	LAN 1	+/-	Note	A

Note: The EUT is operated normal during the test.

## 13 Surge Immunity Test

### 13.1 Test Specification

Basic Standard:	EN 61000-4-5
Wave-Shape:	Battery referenced ports (except at the output of energy sources), Auxiliary a.c. power input ports (rated voltage $\leq 400$ Vrms): 1.2/50 $\mu$ s Open Circuit Voltage 8/20 $\mu$ s Short Circuit Current
Test Voltage:	Line to line: $\pm 0.5$ kV, $\pm 1$ kV, Line to ground: $\pm 0.5$ kV, $\pm 1$ kV, $\pm 2$ kV output impedance of 42 $\Omega$ (40 $\Omega$ and 2 $\Omega$ generator) and a coupling capacitance of 0,5 $\mu$ F
AC Phase Angle (degree):	0°, 90°, 180°, 270°
Pulse Repetition Rate:	1 time / 20 sec.
Number of Tests:	5 positive and 5 negative at selected points

### 13.2 Test Instruments

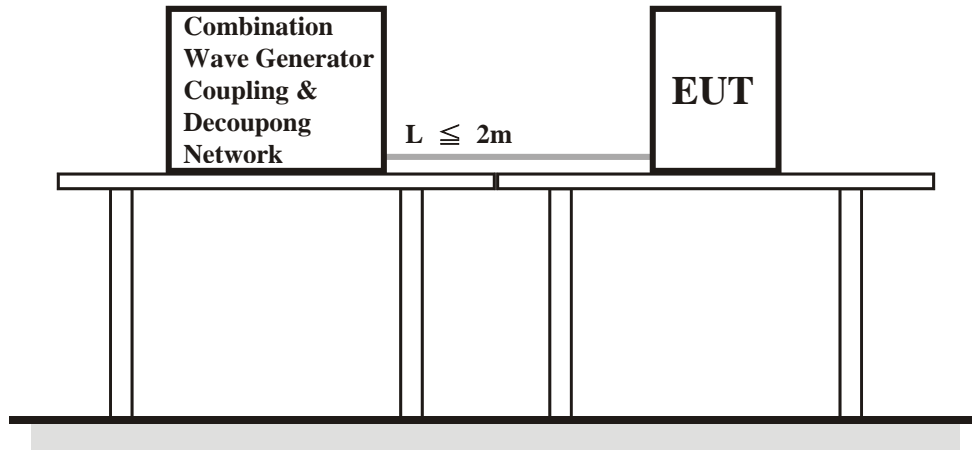
Description & Manufacturer	Model No.	Serial No.	Calibrated Date	Calibrated Until
Surge&EFT Generators TESEQ	NSG 3060	1572	2021/4/24	2022/4/23
Coupling Decoupling Network	CDN-UTP8	045	NA	NA
Coupling Decoupling Network TESEQ	CDN HSS-2	41009	NA	NA
Surge Coupling Decoupling Network TESEQ	CDN 118-T8	40386	2021/9/9	2022/9/8
CDN for Unshielded Unsymmetrical Signal & Data Lines TESEQ	CDN117	40144	2021/9/9	2022/9/8

- Note:
1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.
  2. The test was performed in Linkou EMS 02.
  3. Tested Date: 2022/3/31

### 13.3 Test Arrangement

The surge is to be applied to the EUT power supply terminals via the capacitive coupling network. Decoupling networks are required in order to avoid possible adverse effects on equipment not under test that may be powered by the same lines, and to provide sufficient decoupling impedance to the surge wave. The power cord between the EUT and the coupling/decoupling networks shall be 2 meters in length (or shorter).

For double-insulated products without PE or external earth connections, the test shall be done in a similar way as for grounded products but without adding any additional external grounded connections. If there are no other possible connections to earth, line-to-ground tests may be omitted.



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

### 13.4 Test Results

#### Mode A

Input Power	AC 230V / 50Hz	Environmental conditions	20 °C, 76 % RH
Tested by	Bernie Lu		

Battery referenced ports (except at the output of energy sources),  
Auxiliary a.c. power input ports (rated voltage ≤ 400 Vrms)

Input AC power port					
Voltage (kV)	Test Point	Azimuth(°)	Polarity (+/-)	Observation	Performance Criterion
0.5,1	L – N	0, 90, 180, 270	+/-	Note	A
0.5, 1, 2	L – PE	0, 90, 180, 270	+/-	Note	A
0.5, 1, 2	N – PE	0, 90, 180, 270	+/-	Note	A

Note: The EUT is operated normal during the test.

## 14 Immunity to Conducted Disturbances Induced by RF Fields (CS)

### 14.1 Test Specification

Basic Standard:	EN 61000-4-6
Frequency Range:	0.15 MHz - 80 MHz
Voltage Level:	Battery referenced ports (except at the output of energy sources), Auxiliary a.c. power input ports (rated voltage $\leq$ 400 Vrms), Signal & communication, process measurement & control ports: 10 V
Modulation:	1kHz Sine Wave, 80%, AM Modulation
Frequency Step:	1 % of preceding frequency value
Dwell Time	3 seconds

### 14.2 Test Instruments

Description & Manufacturer	Model no.	Serial No.	Calibrated Date	Calibrated Until
R&S SML03 S.G R&S	SML03	101801	2022/1/11	2023/1/10
Amplifier AR	75A250AM1	306331	NA	NA
Digital Sweep Function Generator Topward	8120	984801	NA	NA
Power Sensor R & S	NRV-Z5	837878/039	2021/10/19	2022/10/18
Power Meter R & S	NRVD	837794/040	2021/10/19	2022/10/18
FCC EM Injection Clamp FCC	F-203I-23mm	455	NA	NA
Current Clamp FCC	F-120-9A	361	2021/8/8	2022/8/7
Coupling/Dcoupling Network EM TEST	CDN M1/32A	306508	2021/6/17	2022/6/16
CDN M2-16Amp FCC	FCC-801-M2-16A	01047	2022/2/23	2023/2/22
Coupling/Dcoupling Network TESEQ	CDN M232	37702	2021/6/17	2022/6/16
Coupling/Dcoupling Network TESEQ	CDN M332	41258	2021/6/17	2022/6/16
Coupling/Dcoupling Network TESEQ	CDN M332	41256	2021/6/17	2022/6/16
Coupling Decoupling Network TESEQ	CDN M432S	56519	2022/2/23	2023/2/22
CDN FCC	FCC-801-M5-50A	100018	2022/1/18	2023/1/17
Coupling Decoupling Network TESEQ	CDN T2A-10	54942	2022/2/22	2023/2/21
Coupling Decoupling Network TESEQ	CDN T400A	49918	2022/2/23	2023/2/22
Coupling Decoupling Network TESEQ	CDN T800	34428	2022/2/22	2023/2/21
Coupling Decoupling Network TESEQ	CDN T8-10	40376	2022/2/22	2023/2/21
Coupling Decoupling Network TESEQ	CDN T8-230	56641	2022/2/22	2023/2/21
Coupling Decoupling Network TESEQ	CDN T8-230	56642	2022/2/22	2023/2/21
Coupling Decoupling Network TESEQ	CDN T8-230	56643	2022/2/22	2023/2/21

CDN Calibration Kit TESEQ	CDN T8S	29459	2021/6/17	2022/6/16
Coupling Decoupling Network TESEQ	CDN ST08A	56527	2022/2/21	2023/2/20
Coupling Decoupling Network TESEQ	CDN ST08A	56525	2022/2/21	2023/2/20
CDN TESEQ	CDN S200	53490	2022/2/24	2023/2/23
CDN TESEQ	CDN S400	52115	2021/6/17	2022/6/16
Coupling Decoupling Network TESEQ	CDN S751A	56435	2022/2/21	2023/2/20
Coupling Decoupling Network TESEQ	CDN S751A	56436	2022/2/22	2023/2/21
Software BVADT	CS_V7.4.2	NA	NA	NA
Audio analyzer R&S	UPV	104565	2021/5/18	2022/5/17
Ear Simulator Telephonometry B&K	4185	2553594	NA	NA
Pressure-field Microphone B&K	4192	3073928	2021/8/12	2022/8/11
Two channel microphone conditioning amplifier B&K	2690 OS2	3001996	2021/11/17	2022/11/16
POWER AMPLIFIER B&K	2716C	2610979	NA	NA
Mouth Simulator B&K	4227	2630632	NA	NA
Software BVADT	ABMS_V7.4.3	NA	NA	NA

- Note:
1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.
  2. The test was performed in CS Room No. 1.
  3. Tested Date: 2022/4/2





#### 14.4 Test Results

##### Mode A

Input Power	AC 230V / 50Hz	Environmental conditions	21 °C, 78 % RH
Tested by	Bernie Lu		

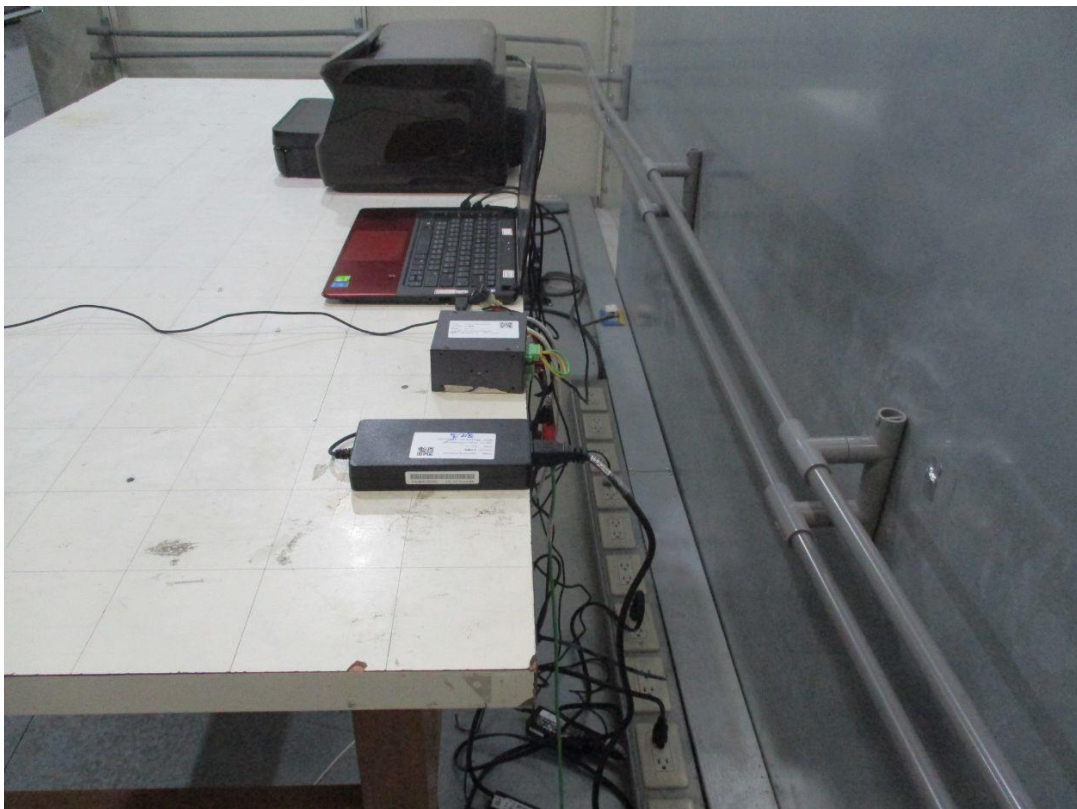
Input AC power port							
Frequency (MHz)	Level (V rms)	Modulation	Tested Line	Injection Method	Return Path	Observation	Performance Criterion
0.15 – 80	10	80% AM (1kHz)	AC power	CDN-M3	CDN-M1	Note	A

Wired network and signal/ control port							
Frequency (MHz)	Level (V rms)	Modulation	Tested Line	Injection Method	Return Path	Observation	Performance Criterion
0.15 – 80	10	80% AM (1kHz)	LAN 1	CDN-ST08A	CDN-M1	Note	A

Note: The EUT is operated normal during the test.

## 15 Pictures of Test Arrangements

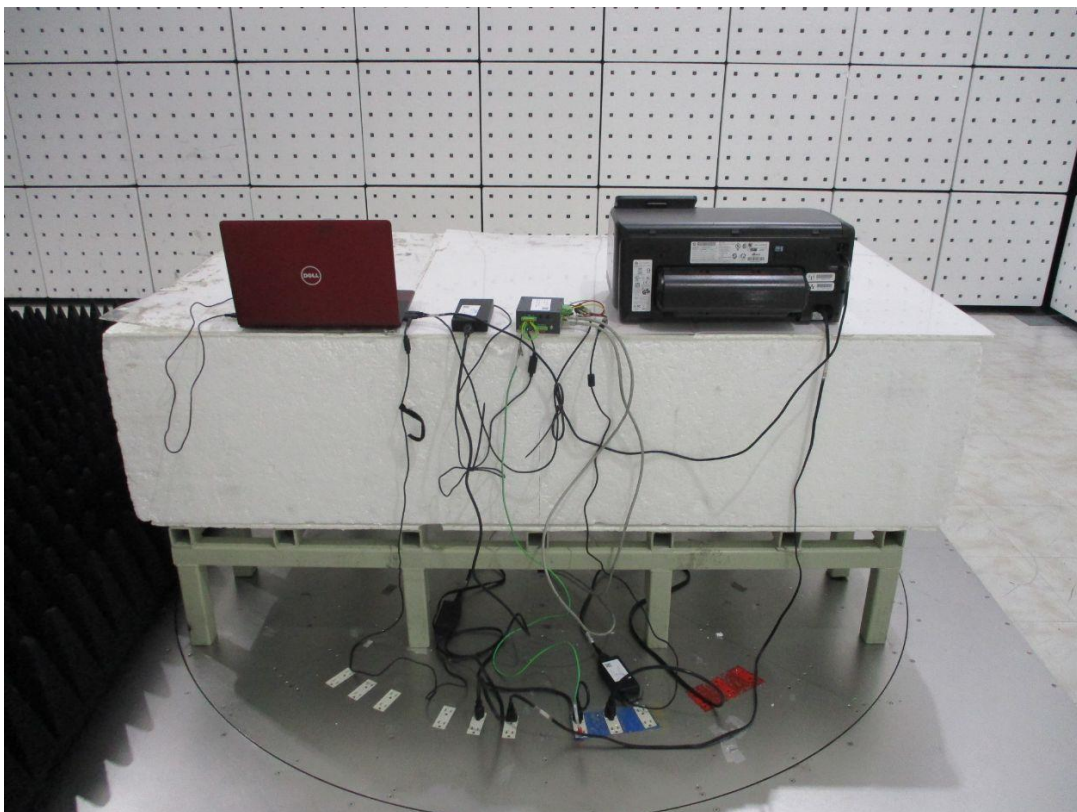
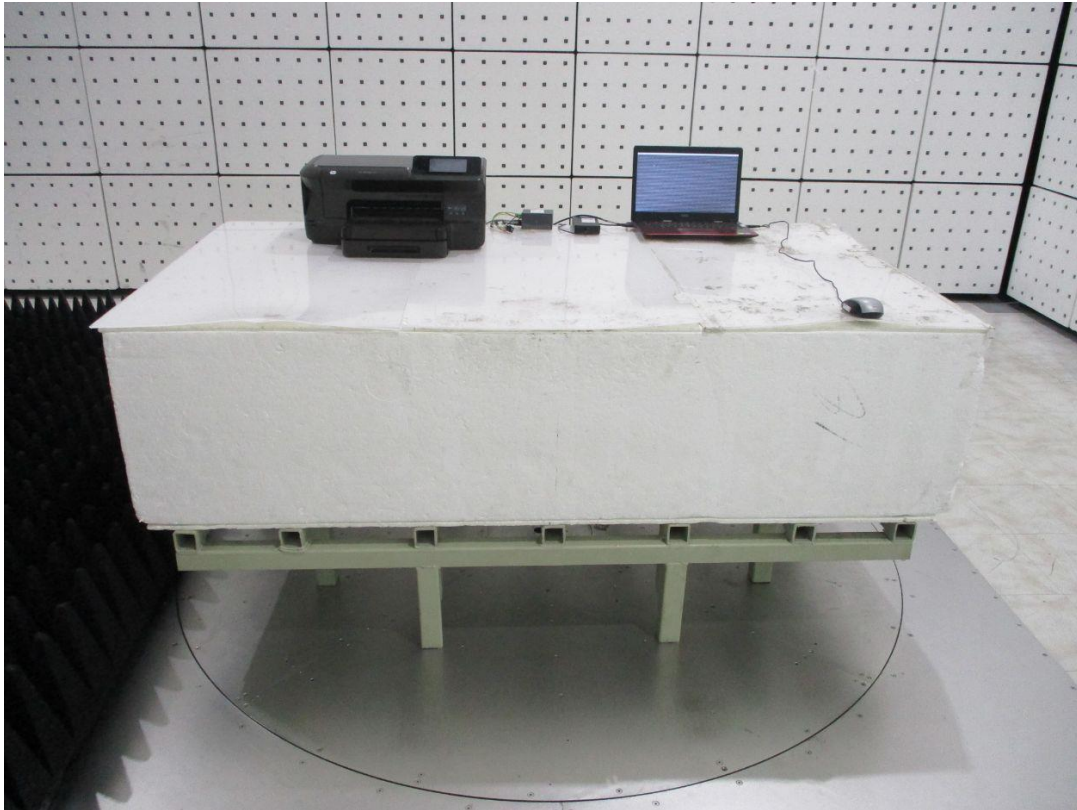
### 15.1 Conducted Disturbance at Auxiliary a.c. or d.c. power ports



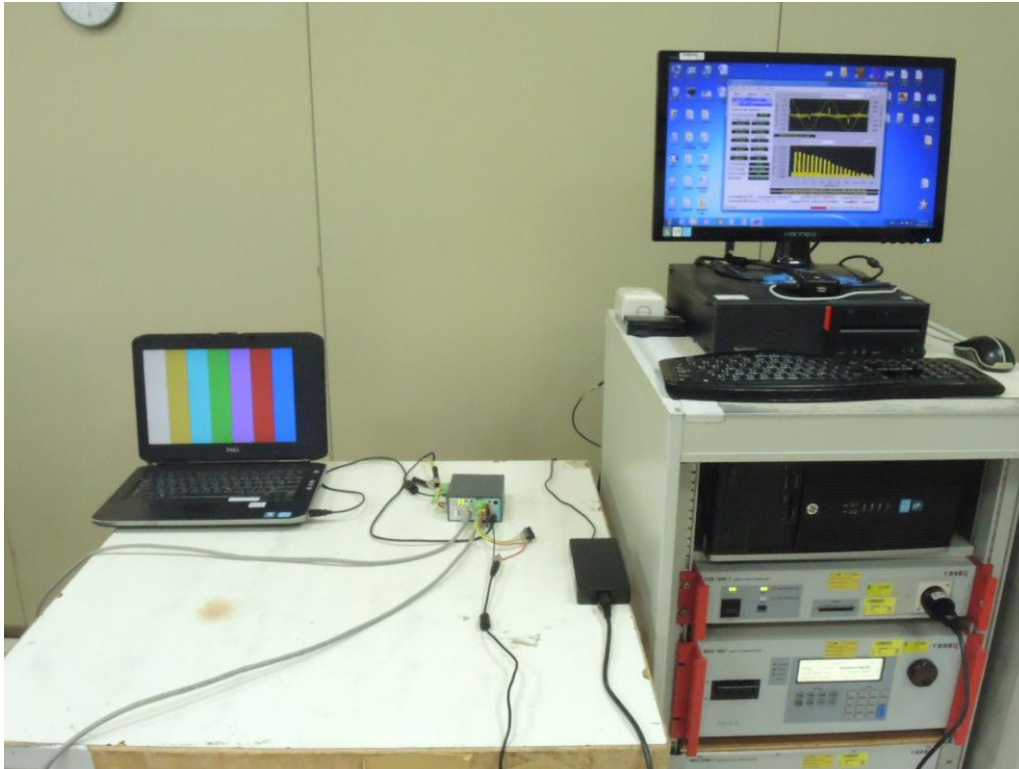
## 15.2 Radiated Disturbance up to 1 GHz



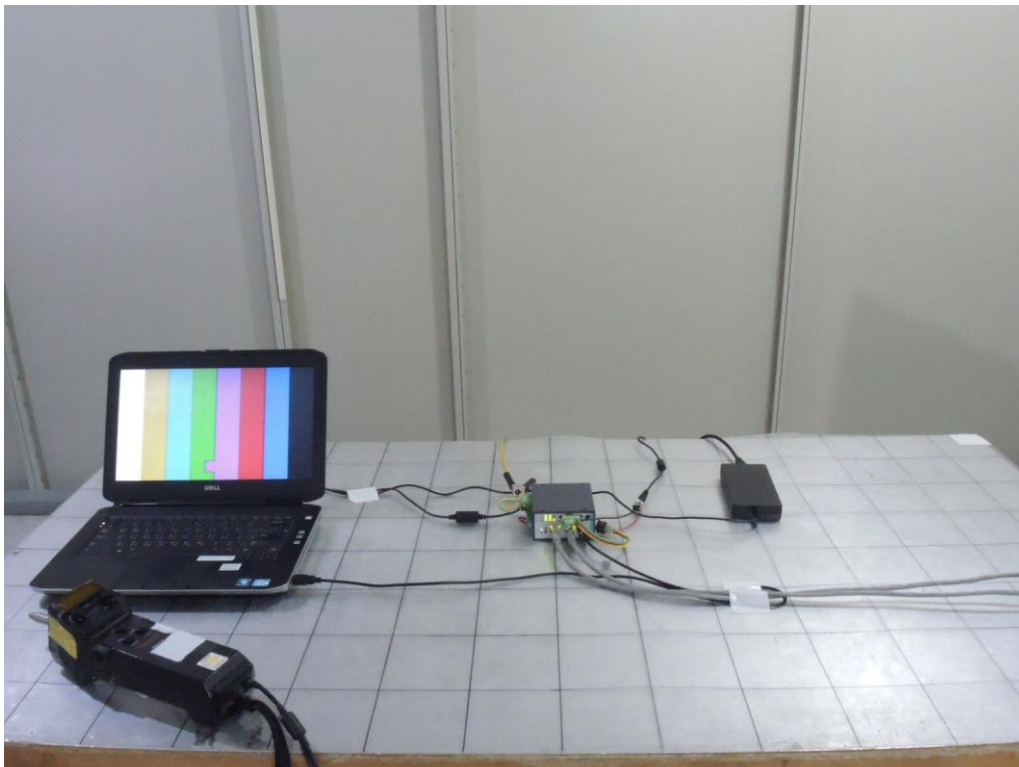
### 15.3 Radiated Disturbance above 1 GHz



#### 15.4 Harmonics Current, Voltage Fluctuations and Flicker Measurement



#### 15.5 Electrostatic Discharge Immunity Test (ESD)



## 15.6 Radio-frequency Electromagnetic Field Immunity Test (RS)



## 15.7 Fast Transients (EFT)

Mains port



LAN



## 15.8 Surge

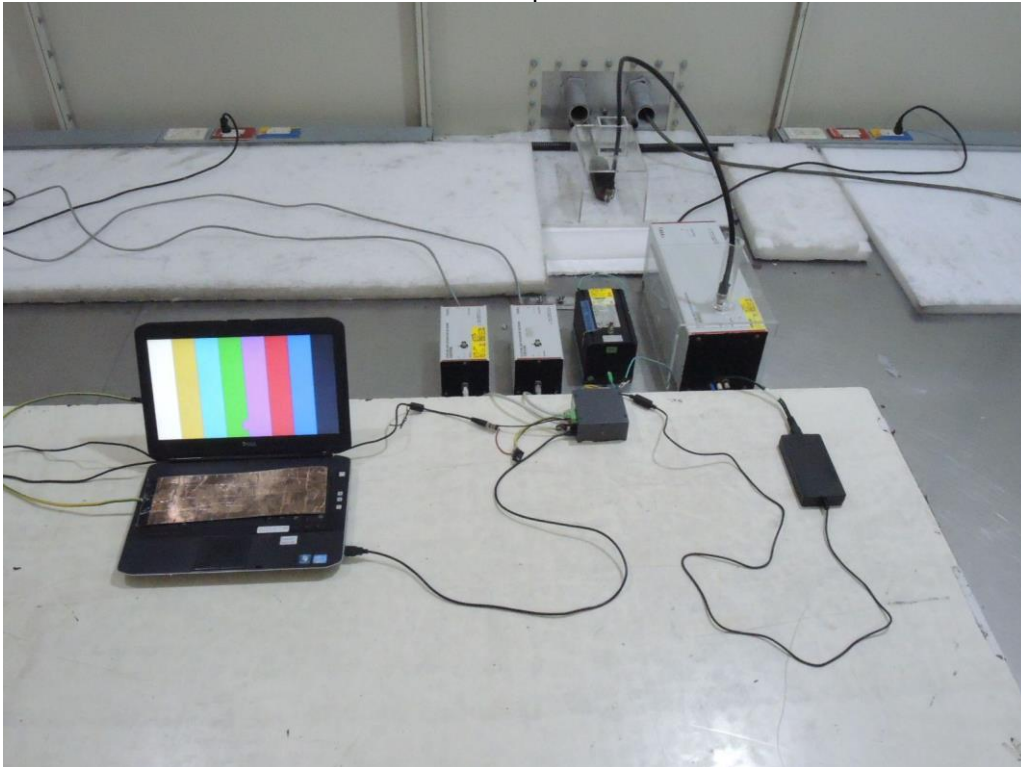
Mains ports



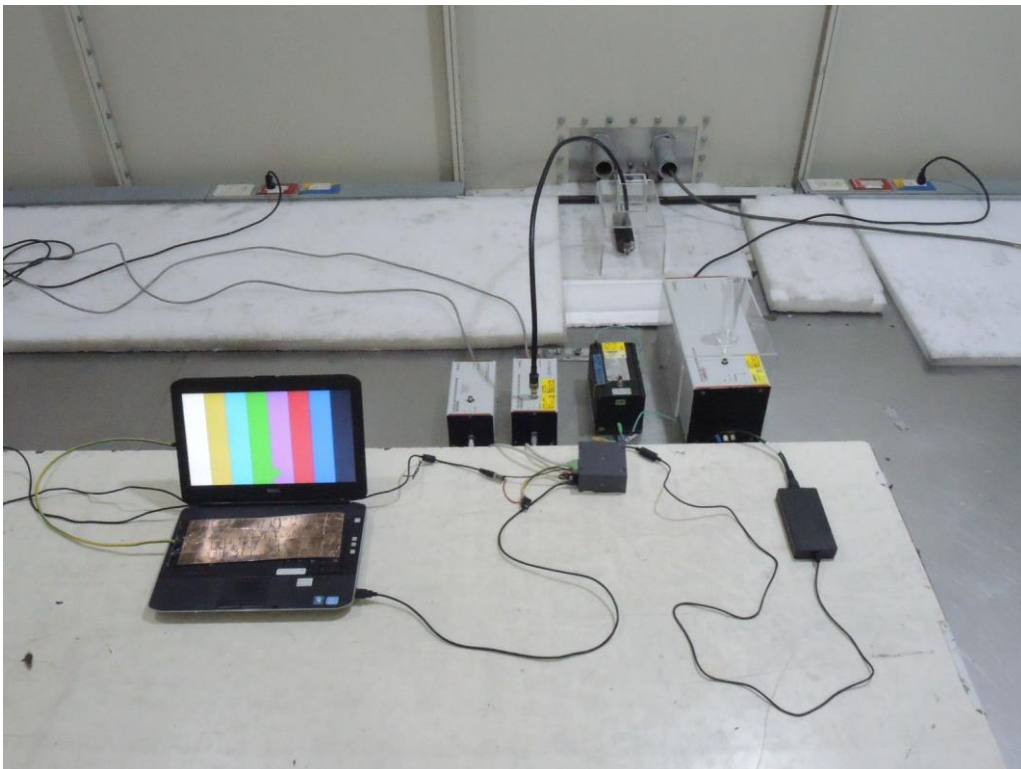


## 15.9 Radio-frequency common mode (CS)

Mains port



LAN



## Appendix – Information of the Testing Laboratories

We, Bureau Veritas Consumer Products Services (H.K.) Ltd., Taoyuan Branch, were founded in 1988 to provide our best service in EMC, Radio, Telecom and Safety consultation. Our laboratories are accredited and approved according to ISO/IEC 17025.

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The address and road map of all our labs can be found in our web site also.

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